

PCB layout guidelines for PSOC™ Edge E84 MCU

About this document

Scope and purpose

This application note provides PCB layout guidelines for a board design based on the Edge E84 MCU device. The Infineon reference schematic and layout files will be supplied (see [\[2\]](#)) and form the basis of the guidelines provided.

This application note gives pointers to more highlights that are possible through placement, stack-up, routing topologies trace, etc. for PSOC™ Edge E84 MCU devices.

Intended audience

This application note is intended for board designers.

Table of contents
Table of contents

	About this document	1
	Table of contents	2
1	Introduction	4
1.1	Package types	4
2	PCB layout routing guidelines: High-speed signals	5
2.1	MIPI-DSI	5
2.2	Serial memory interface (SMIF0/SMIF1)	6
2.3	USB 2.0	6
2.4	HDI vias and stack-up design	7
3	Placement and floor planning	10
3.1	Components, bypass-, and de-coupling capacitors	11
3.2	Serial interface component placements	12
3.3	Multiple power and GND distribution, vias, microvias definition	14
4	General PCB layout tips	16
4.1	Controlled impedance structures in PCB and simulation results	16
4.2	Reference layers for return path of controlled impedance signals	18
5	IPC class type and minimum drill and pad requirements	20
5.1	FBGA-220	20
5.2	eWLB-235	21
5.3	WLB-154	22
6	Reference board breakout and layout recommendations	23
6.1	Layout example summary	23
6.2	FBGA-220 - Breakout and routing example	23
6.2.1	Layer 1: Component placement	23
6.2.2	Layer 2: GND1 reference	24
6.2.3	Layer 3: Signal 1	25
6.2.4	Layer 4: PWR/Signal	26
6.2.5	Layer 5: PWR	27
6.2.6	Layer 6: Signal 2	28
6.2.7	Layer 7: GND2 reference	29
6.2.8	Bottom layer	30
6.2.9	PCB stack-up and vias recommendation	32
6.2.10	HDI vias routing:	32
6.3	eWLB-235 - Ball BGA breakout and routing example	33
6.3.1	Layer1: Top placement	33
6.3.2	Layer 2: GND1 reference	33
6.3.3	Layer 3: Signal 1	34

Table of contents

6.3.4	Layer 4: PWR	35
6.3.5	Layer 5: PWR	35
6.3.6	Layer 6: Signal 2	36
6.3.7	Layer 7: GND2 reference	37
6.3.8	Bottom layer	38
6.3.9	PCB stack-up and vias recommendation	39
6.4	WLB-154 – Ball BGA breakout and routing example	40
6.4.1	Layer 1: Top placement	40
6.4.2	Layer 2: GND1 reference	40
6.4.3	Layer 3: Signal 1	41
6.4.4	Layer 4: Signal 2	42
6.4.5	Layer 5: GND	43
6.4.6	Bottom layer	44
6.4.7	PCB stack-up and vias recommendation	45
7	Layout review checklist	46
8	Conclusion	47
	References	48
	Revision history	49
	Trademarks	50
	Disclaimer	51

1 Introduction

1 Introduction

Packages such as fine-pitch ball grid array (FBGA), embedded wafer-level ball grid array (eWLB), and wafer-level ball grid array (WLB) are becoming increasingly popular. As they are more populated across the array with higher pin count and smaller pitch, it is important to understand how they are affected by various board layout techniques.

This application note provides a brief overview of PCB layout considerations when working with BGA packages. It outlines some of the most common problems and provides tips for avoiding them at the design stage. A key challenge of adopting fine-pitch (0.65 mm or less) BGA packages is the design of a route fanout pattern that maximizes I/O utilization while minimizing fabrication cost.

1.1 Package types

The PSOC™ Edge MCU product line is offered in the following packages.

Table 1 Package types

Package	Description	Package dwg#
FBGA-220	BGA-220, 10 mm x 10 mm x 1.2 mm height with 0.65 mm pitch	PG-VFBGA-220-1
eWLB-235	BGA-235, 7 mm x 7 mm x 0.685 mm height with 0.4 mm pitch	PG-WFWLB-235-1
WLB-154	BGA-154, 5.281 mm x 4.281 mm x 0.505 mm height with 0.350 mm pitch	SG-XFWLB-154-1

See the package drawing details in the datasheet [\[2\]](#) for mechanical dimension details of the packages.

2 PCB layout routing guidelines: High-speed signals

2 PCB layout routing guidelines: High-speed signals

The following guidelines provide the recommended impedance, trace width/spacing, total length limitation, and length matching requirements to achieve optimal signal integrity and timing margins.

- The exact values of signal trace width and trace spacing should be determined based on the trace impedance requirement.
- It is recommended to have a solid GND as reference for all signal routing layers. Reference planes should avoid any gaps or voids to minimize return current discontinuity.
- Isolate the ground return path of analog signals from digital noise whenever applicable.
- The power layer should only be considered as a secondary signals reference option where a solid continuous ground reference is present.
- Electrical properties of the recommended signal routing are based on dielectric material with FR4 assumption.

Infineon recommends that the GND plane be used as the primary reference or return paths for all signals. Whenever a power layer is used as reference plane, it is important to ensure that the power layer is low-noise and there is proper stitching at the reference plane transitions to guarantee return path continuity (especially at high frequency).

Consider performing signal integrity simulations using Infineon-provided IBIS models to determine actual guidelines suitable for your application. The following guidelines should be used as a starting reference.

2.1 MIPI-DSI

	DSI.CLKP
	DSI.CLKN
	DSI.DATA0P
	DSI.DATA0N
	DSI.DATA1P
	DSI.DATA1N

Figure 1 MIPI-DSI layout

- **Line impedance:** Differential $100\ \Omega \pm 10\%$
- **Line length difference:** The line length between the differential clock and differential data should be the same length as much as possible $\pm 25\ \text{mil}$ (CK/CK# to DQ $\pm 25\ \text{mils}$)
- **Signal line layer:** The numbers of vias between differential clocks should be maintained at the same number of vias for break out and layer transition
- **Recommended routing:** Top layer without any vias. In case of internal layer routing, same via number (the number should be as few as possible)
- **Return path:** Place continuous ground plane under differential-signal placed GND through-hole via next to signal through-hole placed GND vias symmetrically next to differential signals
- **Between differential and next differential :** $\geq 3S$ when there is no GND shield

Minimum trace width and trace spacing is based on via size defined inside the BGA area. Once the routing clears the breakout region, it is recommended to follow the general routing guidelines. It is preferable to use μ vias or buried vias instead of through-hole vias to avoid neck width issues.

2 PCB layout routing guidelines: High-speed signals

2.2 Serial memory interface (SMIF0/SMIF1)

SMIF0.0	SMIF1.0
SMIF0.1	SMIF1.1
SMIF0.2	SMIF1.2
SMIF0.3	SMIF1.3
SMIF0.4	SMIF1.4
SMIF0.5	SMIF1.5
SMIF0.6	SMIF1.6
SMIF0.7	SMIF1.7
SMIF0.RWDS	SMIF1.RWDS
SMIF0.CLKP	SMIF1.CLKP
SMIF0.CLKN	SMIF1.CLKN

Figure 2 Serial memory interface (SMIF0/SMIF1)

- **Line impedance:** Differential $100\ \Omega \pm 10\%$, Single ended $50\ \Omega \pm 10\%$
- **Line length difference:** The line length between differential clock should be the same length as much as possible (± 1 mils). Total line length should be as short as possible. (CK/CK# to DQ ± 500 mils)
- **Signal line layer:** The numbers of vias between differential clocks should be maintained at the same number of vias for break out and layer transition
- **Recommended routing:** Top layer without any vias in case of internal layer routing Same via the number (the number is as few as possible)
- **Return path:** Place continuous ground plane under differential-signal placed GND through-hole via next to signal through-hole placed GND vias symmetrically next to differential signals

The skew is introduced into the clock system by unequal trace lengths. To minimize the board skew, keep the trace lengths equal between the data and clock.

Minimum trace width and trace spacing based on via size should be defined inside the BGA area. Once the routing clears the breakout region, it is recommended to follow the general routing guidelines.

2.3 USB 2.0

- **Line impedance:** Differential $90\ \Omega \pm 10\%$
- **Line length difference:** Differential pair trace length P and N should be kept same as much as possible and line length as short as possible
- **Return path:** Place continuous ground plane under differential-placed GND through-hole next to signal through-hole placed GND vias symmetrically next to differential

2 PCB layout routing guidelines: High-speed signals

The skew is introduced into the system by unequal trace lengths. To minimize the board skew, keep the trace lengths equal between P and N.

Table 2 Summary of PCB signal lines for high-speed peripherals

Peripherals	Impedance and tolerance	Routing	Frequency
MIPI-DSI	100 Ω +/- 10%	Differential	1500 Mbps
SMIF	50 and 100 Ω +/- 10%	Differential and single-ended	200 MHz
USB	90 Ω +/- 10%	Differential	480 Mbps

2.4 HDI vias and stack-up design

PCB designers need to figure out the number of layers required to fan out a FBGA-220. Consequently, the designer determines on which layers the critical signals are routed and the number of power and ground layers required. All the parameters described in [PCB layout routing guidelines: High-speed signals](#) help determine the number of layers in the stack.

HDI vias routing: HDI type via interconnect is used for this complex board break out.

Advantages

- This stack via technology results in a board that is highly routable
- Minimum layers are enough to complete the breakout and routing

Disadvantages

- Extra steps are required in the processing flow due to special drilling and plating of the lamination

2 PCB layout routing guidelines: High-speed signals

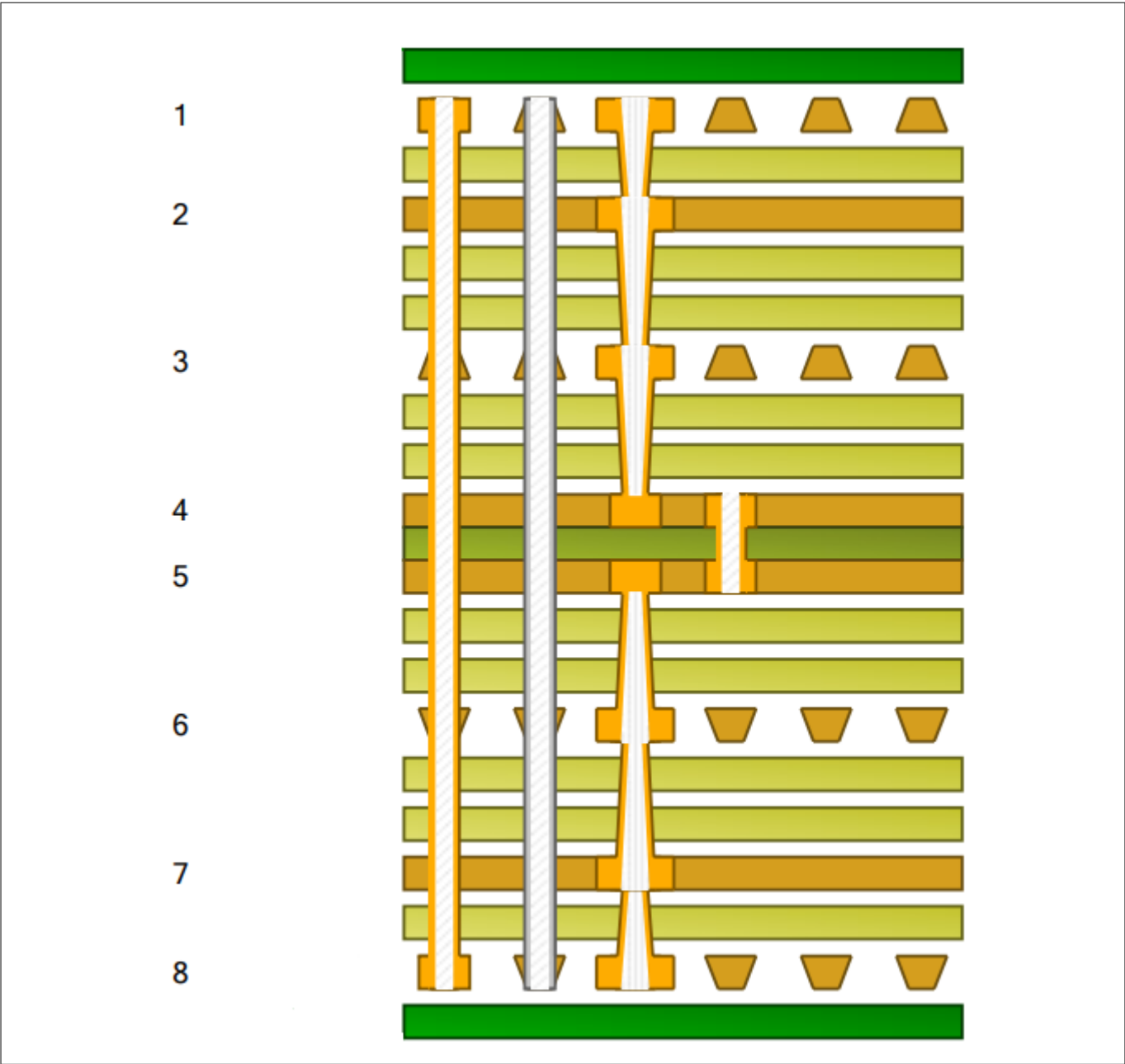


Figure 3 Stack-up pattern

LAYER DESCRIPTION	COPPER WT	SE IMP OHMS	SE TRACE WIDTH	SE TRACE WIDTH W/O SM	REF LAYER	CPW (50E) WIDTH/SPACE	REF LAYER	CPW (50E) WIDTH/SPACE	REF LAYER	DIFF IMP OHMS	DIFF TRACE WIDTH/SPACE	DIFF TRACE WIDTH/SPACE W/O SM	REF LAYER	DIFF IMP OHMS	DIFF TRACE WIDTH/SPACE	REF LAYER
L01 - TOP	1.85	50E	6.2/4.5	7.35	L2	5.0/4.5	L2	16.8/15	L3	100E	3.5/4.4	5.0/4.0	L2	90E	4.65/4.35	L2
L02 - GND1	1.85	---	---	---	---	---	---	---	---	---	---	---	---	---	---	---
L03 - SIG1	1.85	50E	4.0	---	L2	---	---	---	---	100E	3.5/7.1	---	L2	90E	4.5/7.1	L2
L04 - PWR1	2.067	---	---	---	---	---	---	---	---	---	---	---	---	---	---	---
L05 - PWR2	2.067	---	---	---	---	---	---	---	---	---	---	---	---	---	---	---
L06 - SIG2	1.85	50E	4.0	---	L7	---	---	---	---	100E	3.5/7.1	---	L7	90E	4.5/7.1	L7
L07 - GND2	1.85	---	---	---	---	---	---	---	---	---	---	---	---	---	---	---
L08 - BOT	1.85	50E	6.2/4.5	---	L7	---	---	---	---	100E	3.5/4.4	---	L7	90E	4.65/4.35	L7

STACK-UP (UNITS IN MILS)

Figure 4 1.2 mm, 8-layer PCB stack-up

2 PCB layout routing guidelines: High-speed signals

A total of eight layers are used and materials used are **FR4** or equivalent. The dielectric constant (Er) or relative permittivity (Dk) of a PCB material is generally between 4.3 and 4.8. A material's Er level depends on the frequency and will usually drop as the frequency rises.

3 Placement and floor planning

3 Placement and floor planning

The floor plan links the schematic drawing and the layout. It provides a head start to the designer on component placement. A pre-placement floor plan will allow optimization of the component placement form factor and signal integrity goals. Also, the small components, like bypass capacitors and termination resistors, should be placed at an early stage. The functional blocks of circuitry like power conditioning, digital, analog, etc., should be arranged as groups to reduce signal crossing.

A floor plan gives an insight into how the signals flow between functional blocks.

For an efficient board;

- Group the power conditioning together so that their signals do not have to cross through sensitive areas of circuitry
- Plan your placement to keep the connection lengths as short as possible
- Place the components that are part of high-speed signal paths where multiple nets connect a series of components close together
- Consider the routing channels while planning the component placement to ensure there is adequate space
- Consider the requirements of power and ground planes should when planning out the placement of functional blocks of circuitry

When dealing with split power planes, be cautious while placing the connected components across the split. The high-speed transmission lines should not cross the splits in power planes since it will break up the return path for those signals. Finally, avoid placing components of a different functional group during another circuit. even this will affect the return path of the circuit.

The following figures show the PSOC™ Edge E84 MCU FBGA-220 placement and associated parts placement.

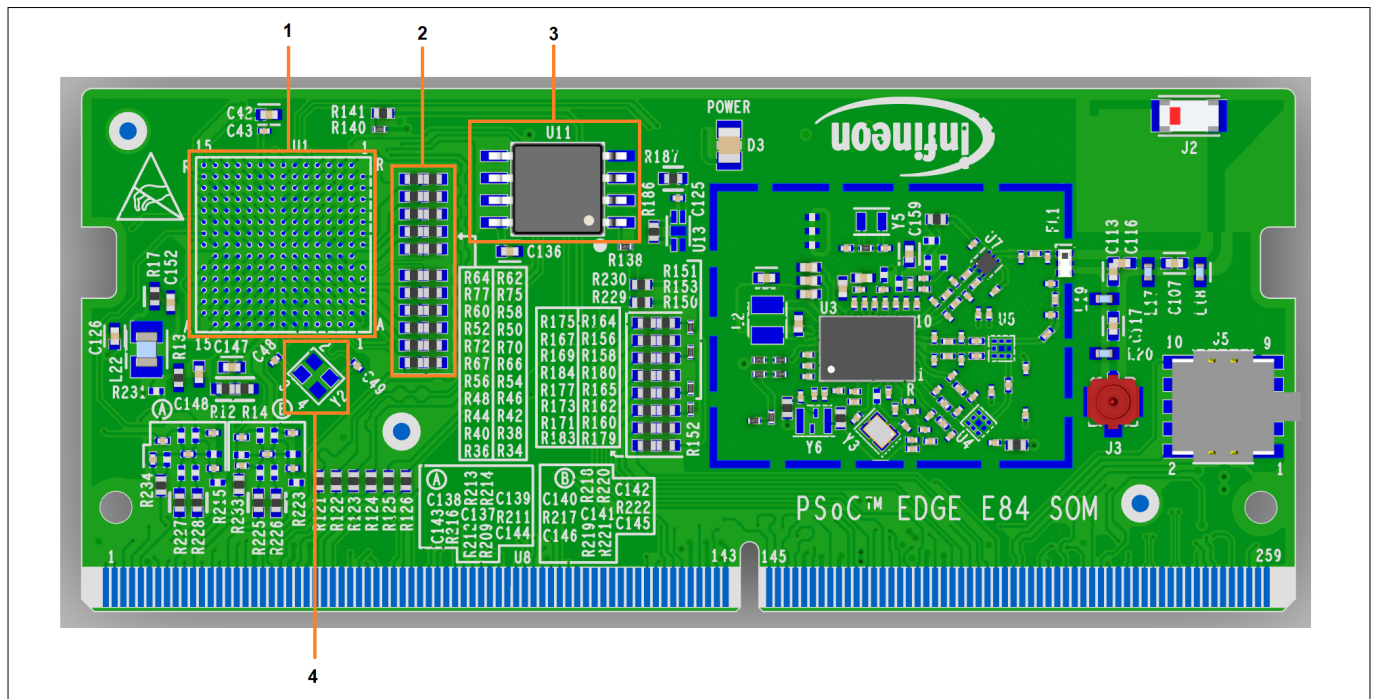


Figure 5 PSOC™ Edge E84 MCU - Top view

3 Placement and floor planning

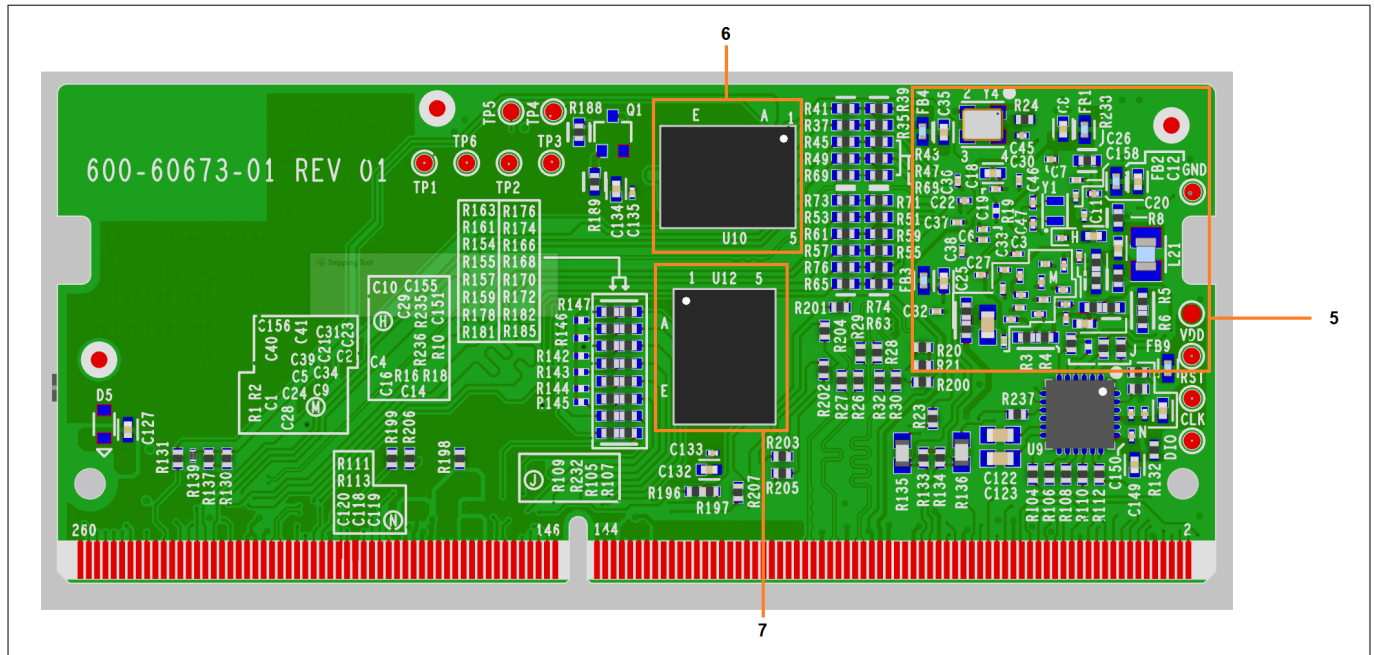


Figure 6 PSOC™ Edge E84 MCU - Bottom view

Where:

1. PSOC™ Edge E84 MCU (FBGA-220, U1)
2. Termination resistors
3. 128-Mbit Quad-SPI NOR flash
4. XTAL, 17.2032 MHz, 10 ppm
5. PSOC™ Edge E84 MCU (FBGA-220, U1) Decoupling capacitors and associated parts
6. 1-Gbit Octal-SPI NOR flash (U10)
7. 128-Mbit Octal-SPI HYPERRAM™ (U12)

3.1 Components, bypass-, and de-coupling capacitors

The standard decoupler for external power is a 1 μ F capacitor.

Supplementary 0.1 μ F capacitors should be placed as close as possible to the VSS and VDD pins of the device to reduce high-frequency power supply ripple. Generally, decouple all sensitive or noisy signals to improve the EMC performance. Decoupling can be both capacitive and inductive.

The decoupling capacitors and the inductor (buck inductor) should be placed as close as possible to the device pins with minimum trace resistance.

3 Placement and floor planning

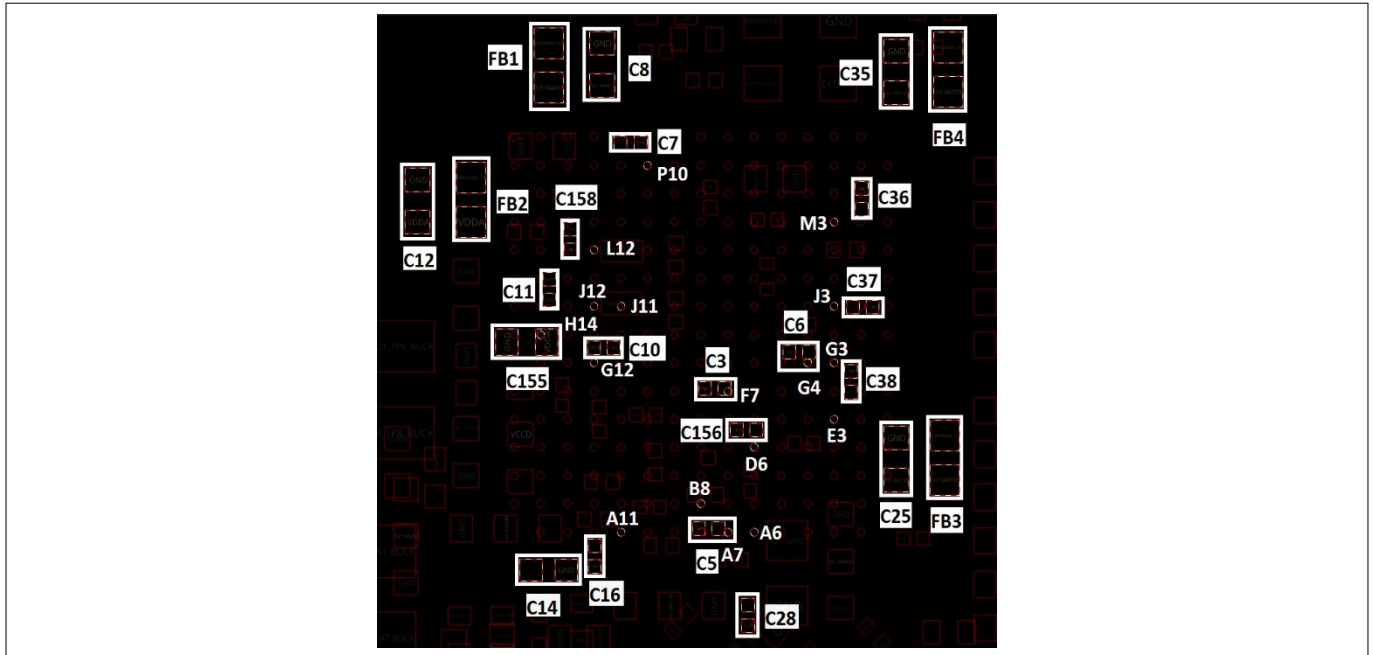


Figure 7 Capacitor and inductor PCB secondary side placement

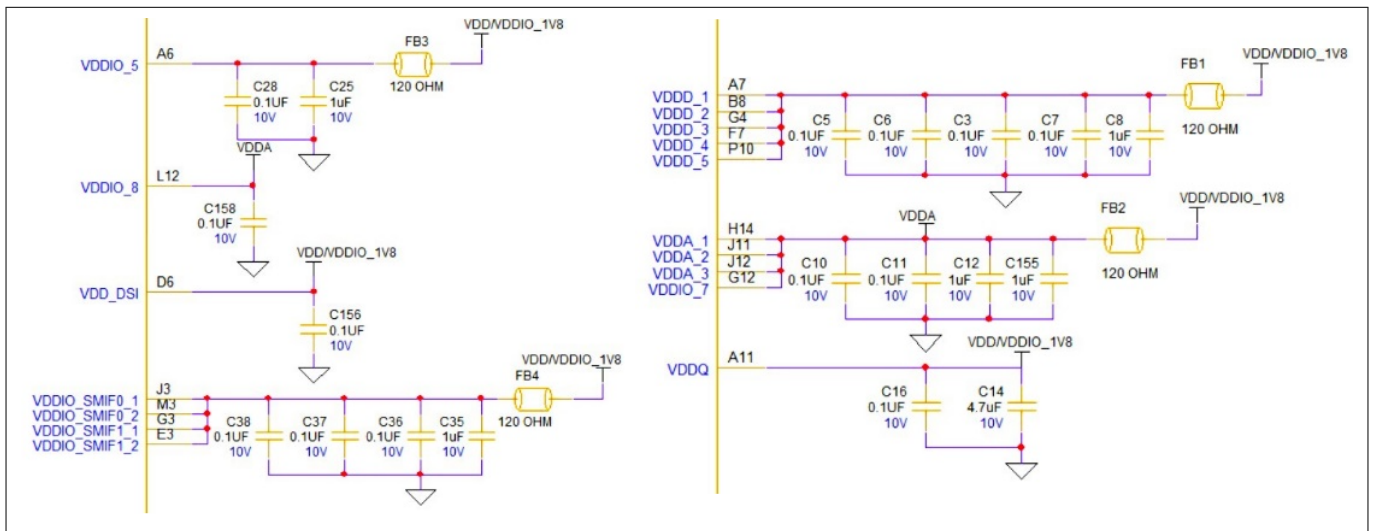


Figure 8 Capacitor and inductor schematic sect

3.2 Serial interface component placements

Segregate the circuits on the PCB according to their functional contribution. This helps reduce cross-coupling on the PCB. For example, separate all critical control impedance circuits, analog, CAPSENSE™ circuits. The crystal oscillator placement is critical and trace length should be as close as possible and maintain the same length ± 1 mils.

3 Placement and floor planning

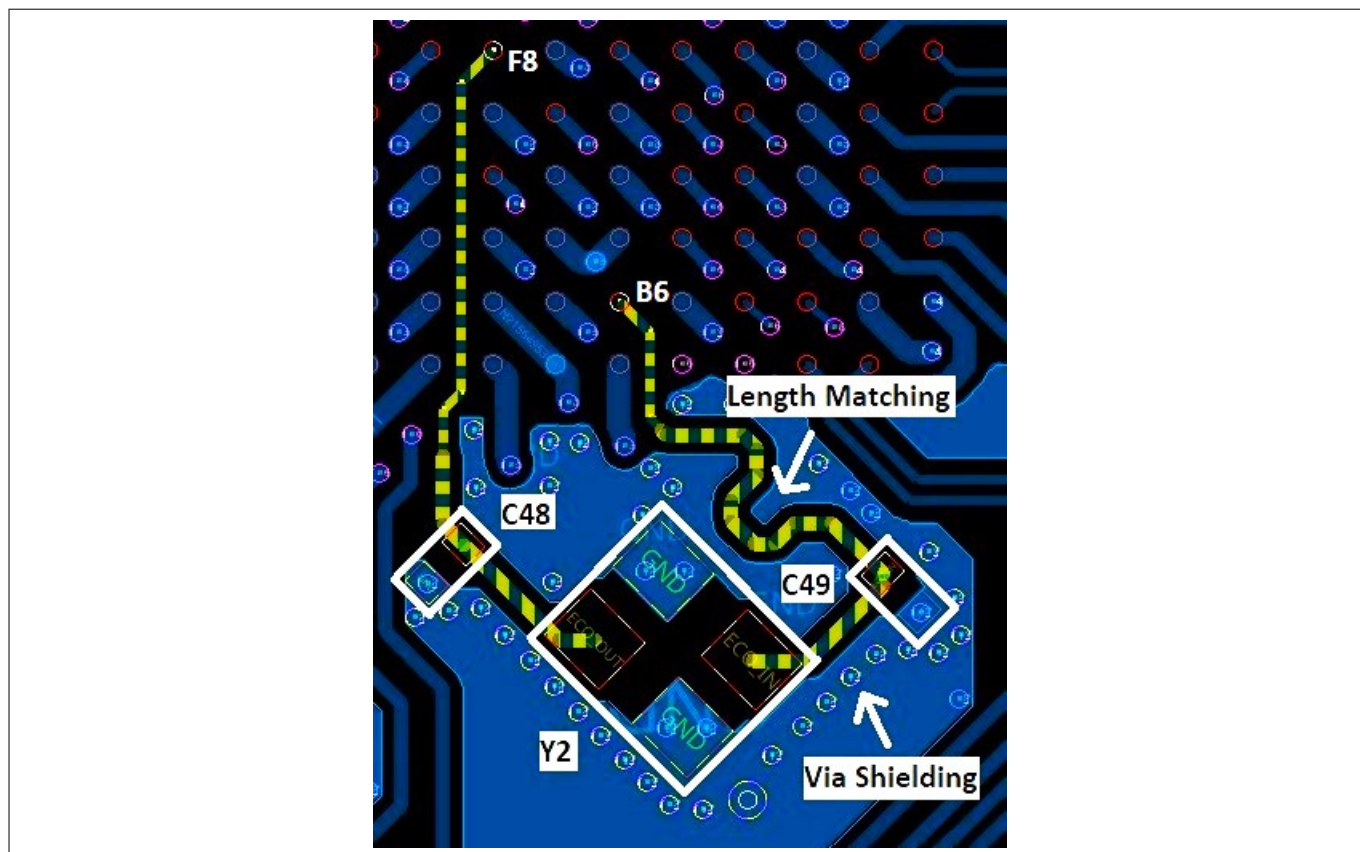


Figure 9 Crystal placement and routing

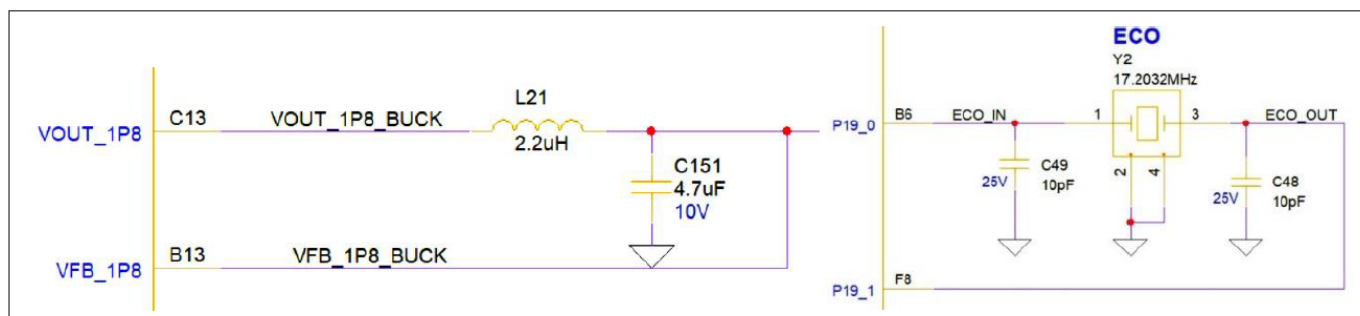


Figure 10 Schematic section of crystal

Separate the circuits on the PCB according to their EMI contribution. This helps reduce cross-coupling on the PCB. For example, separate noisy high-current circuits, low-voltage circuits.

3 Placement and floor planning

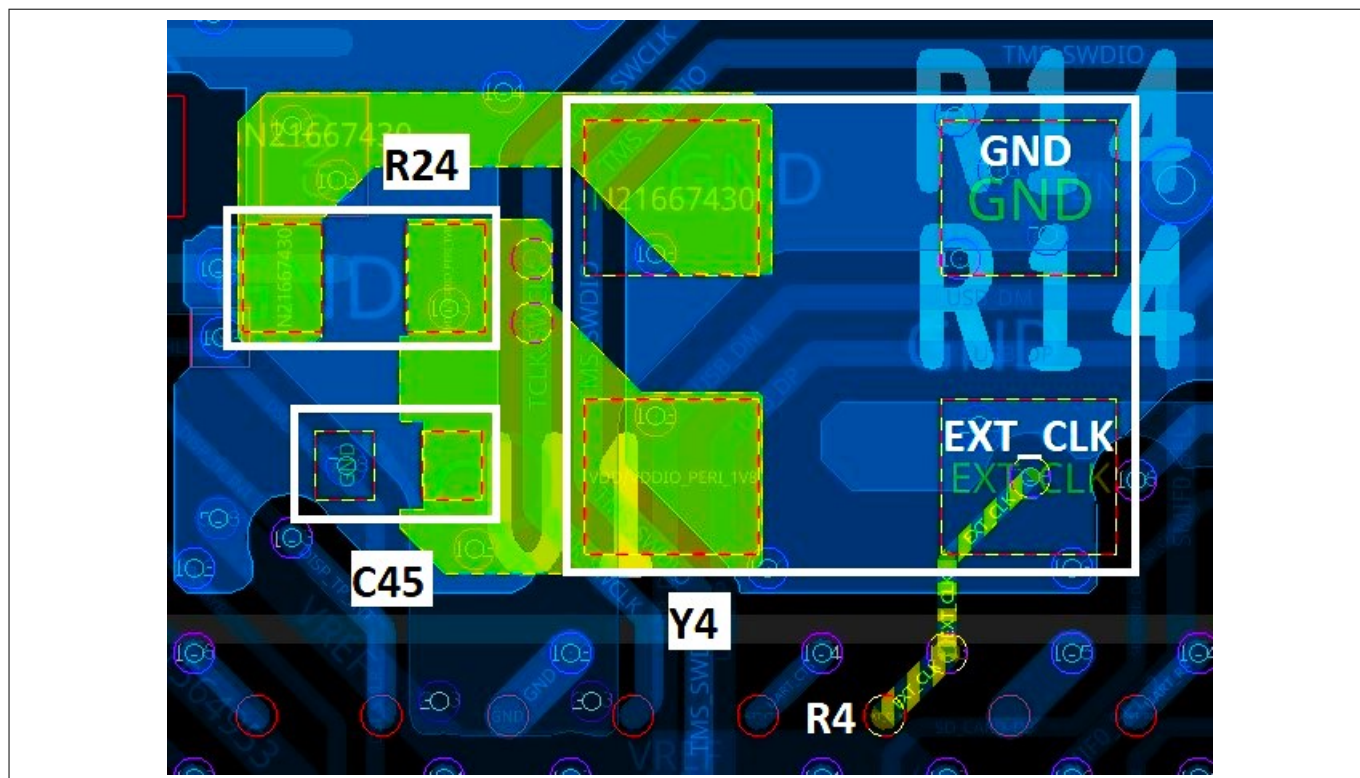


Figure 11 EMI contribution-based placement

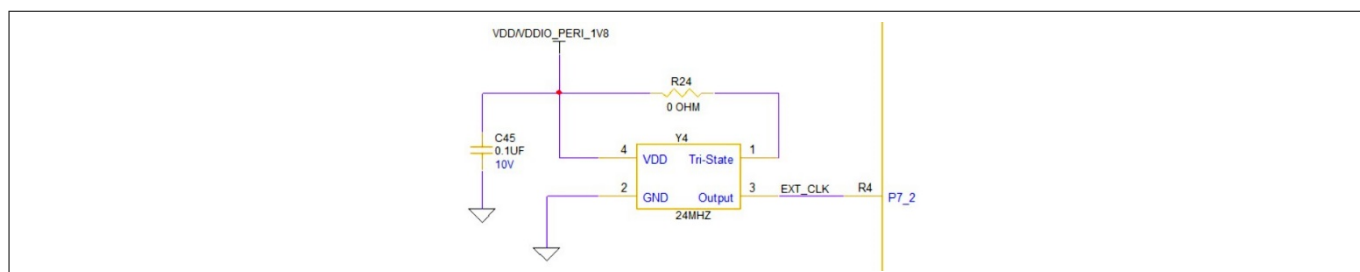


Figure 12 EMI contribution-based placement - Schematic

3.3 Multiple power and GND distribution, vias, microvias definition

Ground and power supply

There should be a single point for gathering all ground returns. Avoid ground loops or minimize their surface area. All component-free surfaces of the PCB should be filled with additional grounding to create a shield. Especially when using high density multilayer PCBs, the power supply should be close to the ground line to minimize the area of the supply loop. Also, add sufficient copper area for high current and add sufficient vias for the path to improve current carrying capacity.

The following table provides the maximum current requirements on PSOC™ Edge MCU power rails.

Table 3 Maximum current requirements on PSOC™ Edge MCU power rails

Net name	Maximum current	Width (mils)
VBAT_MCU	900 mA	25 mils
VDDIO	900 mA	25 mils

(table continues...)

3 Placement and floor planning

Table 3 (continued) Maximum current requirements on PSOC™ Edge MCU power rails

Net name	Maximum current	Width (mils)
VDDA	900 mA	25 mils
VDDD	900 mA	25 mils
VDD_MEM_1V8	400 mA	10 mils
VDDUSB_3V3	300 mA	4–5 mils
VCCD_ANA	60 mA	3–4 mils
VCCSRAM	60 mA	3–4 mils
VCCRET	20 mA	3–4 mils
SR Output	400 mA	3–4 mils

Use power supply traces wide enough to support the required currents.

For example, a 10 mil, half-ounce copper trace can handle 500 mA (at 10°C). The width must be increased to 25 mils for 900 mA. Current carrying capacity goes up to 700 mA for 10 mils and 1.5 A for 25 mils at 30 °C for the same half-ounce copper weight.

For more information on power supply design calculations, see [PCB Design calculator](#).

Microvias

Microvias handle less current than through-vias. Therefore, multiple microvias may be required in some cases. A detailed power layout is shown in [FBGA-220 - Breakout and routing example](#).

4 General PCB layout tips

4 General PCB layout tips

There are many classic techniques for designing PCBs for low noise and EMC. This section describes some of these general techniques that can be used to improve the overall design of the system, EMI/EMC performance, noise handling, and so on.

- **Multiple layers:** Although they are more expensive, it is best to use a multi-layer PCB with separate layers dedicated to the VSS and VDD supplies. This provides good decoupling and shielding effects. Separate fills on these layers should be provided for VSS, VBAT, VDDIO, VDDA, and VDDD. In this case, you must have a good layout to support for all signal/power pins break out and taking care of all control impedance requirement, power, and ground trace. Therefore, minimum recommended layers are between six to eight
- **Ground and power supply:** There should be a single point for gathering all ground returns. Avoid ground loops or minimize their surface area. All component-free surfaces of the PCB should be filled with additional grounding to create a shield, especially when using six layer or eight-layer PCBs. The power supply should be close to the ground line to minimize the area of the supply loop. The supply loop can act as an antenna and can be a major emitter or receiver of EMI
- **Signal routing:** When designing an application, the following areas should be closely studied to improve the EMC performance:
 - Noisy signals, for example, signals with fast edge times
 - Sensitive and high-impedance signals
 - Signals that capture events, such as interrupts and strobe signals

To improve the EMC performance, keep the trace lengths as short as possible and isolate the traces with VSS traces. To avoid crosstalk, do not route them near to or parallel to other noisy and sensitive traces.

4.1 Controlled impedance structures in PCB and simulation results

Dos and Don'ts

- **Critical length:** It is exceeded when the time to propagate a conductor's length is greater than 1/4 of the signal rise or fall time, whichever is faster. This leads to various problems.
If the total interconnect of the net is greater than its critical length, it must be managed with the constraints or different methods of managing it should be followed. Total interconnect length includes pin-package, routing, and via-used lengths.
Reference planes, termination, and impedance as they are essential for critical length nets
- **Maximum length constraints:** Create constraints based on edge rates to identify critical length nets in the design by classes
- **Placement:** Use the maximum length rule as a filter during placement to discover which nets have exceeded their critical length. Then, move the components closer to possibly prevent the nets from exceeding their critical length
- **Routing:** During routing, some nets may exceed their critical length due to excessive meandering. A maximum length rule would flag them
- **Simulation:** When working with high-speed signals, it is imperative to simulate to ensure timing, signal integrity (SI), and electromagnetic interference (EMI) problems are mitigated sufficiently to produce a layout that works as intended

Note: *Propagation delay (Tpd) of differential pairs is about 9% faster than single-ended nets in the same dielectric constant and therefore, the critical length for differential pairs is about 9% shorter.*

The SI report for the multi-board system for PSOC™ 6 SOM SMIF0 interface along with mating board, M.2 memory is shown in the following figures.

- Single board, Octal flash, and Quad flash SMIF0 differential routing SOM board ([Figure 13](#))
- Single-ended clock double data rate ([Figure 14](#) and [Figure 15](#))

4 General PCB layout tips

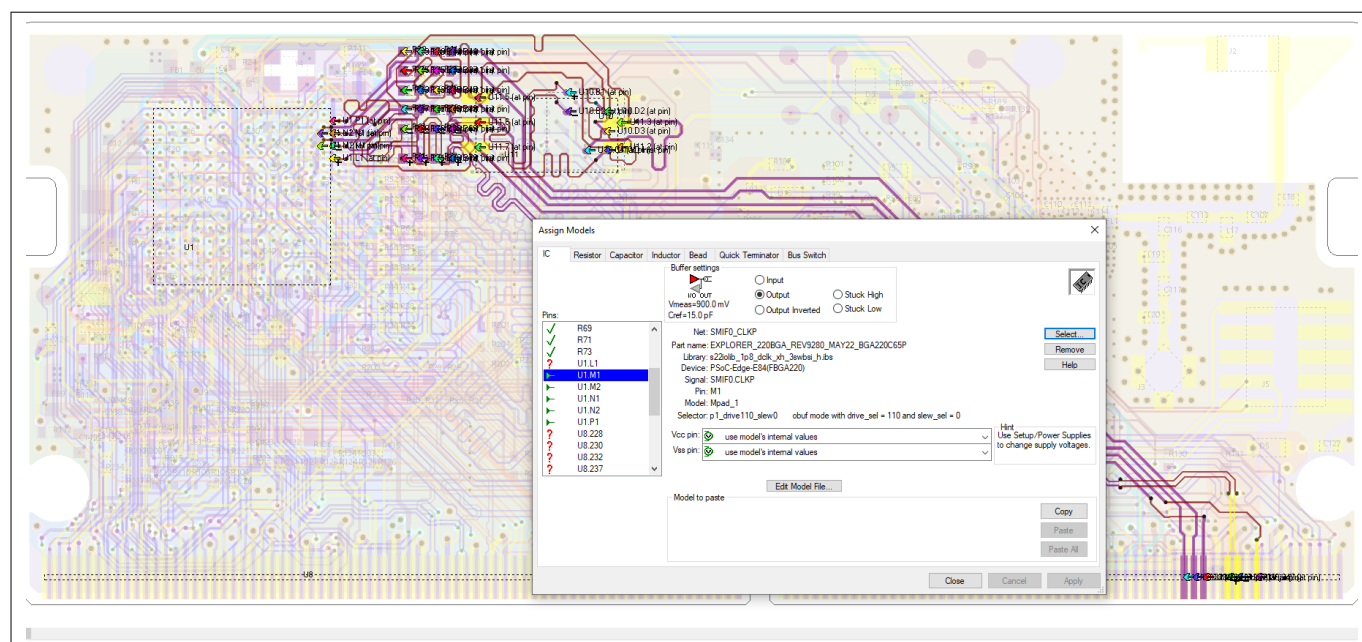


Figure 13 SMIF0 differential routing SOM board

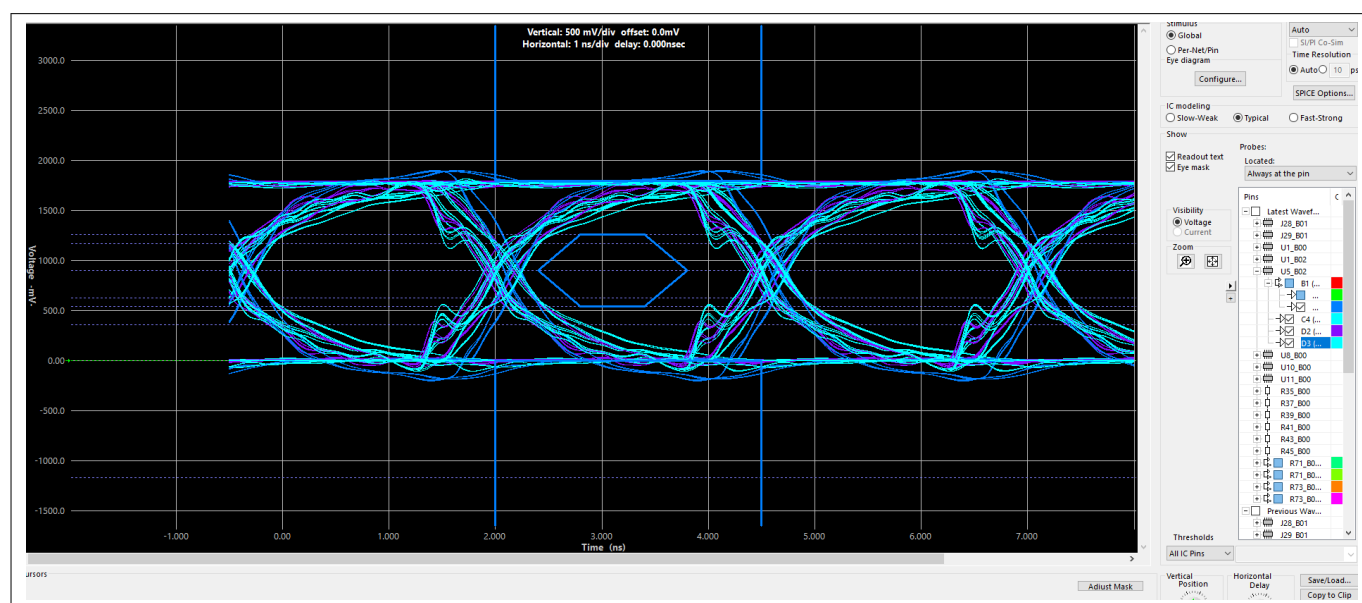


Figure 14 Output waveform at the receiver

4 General PCB layout tips

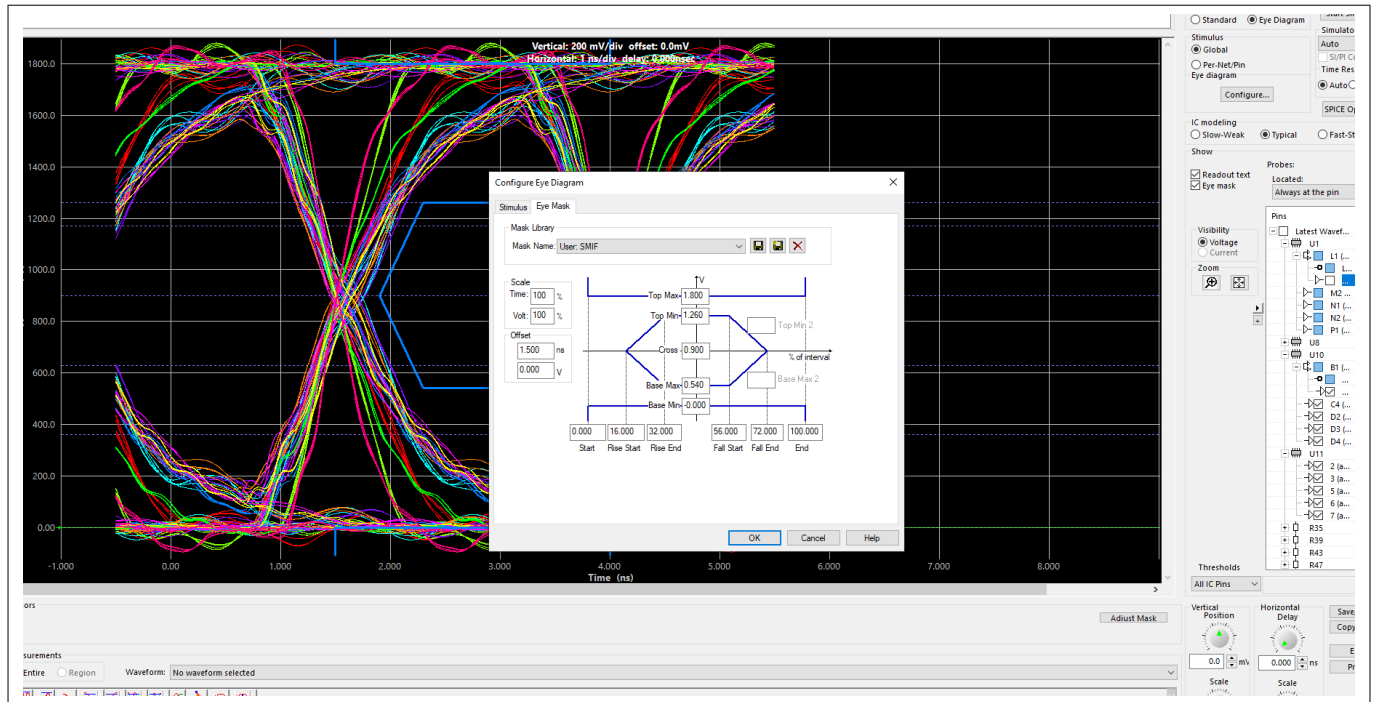


Figure 15 Output waveform at the receiver end

Summary

- All SMIF simulation is carried out with 200 MHz clock and write only operation
- Even if the overall length of the trace is exceeded with respect to the datasheet, it is still within the margin for set up and hold time with fast drive mode
- All the simulation is done as per the single ended clock and individual path enabled one for onboard only and another with external M.2 memory path only
- All the series termination resistors are simulated with 33E for the clock and 45E for the data

4.2 Reference layers for return path of controlled impedance signals

High-speed signals must have continuous coupling to an effective copper path to establish a reference for return currents or there will be significant EMI, crosstalk, and impedance problems. The reference should be through a solid plane.

Total interconnect length includes pin-package, trace routing, and via.

4 General PCB layout tips

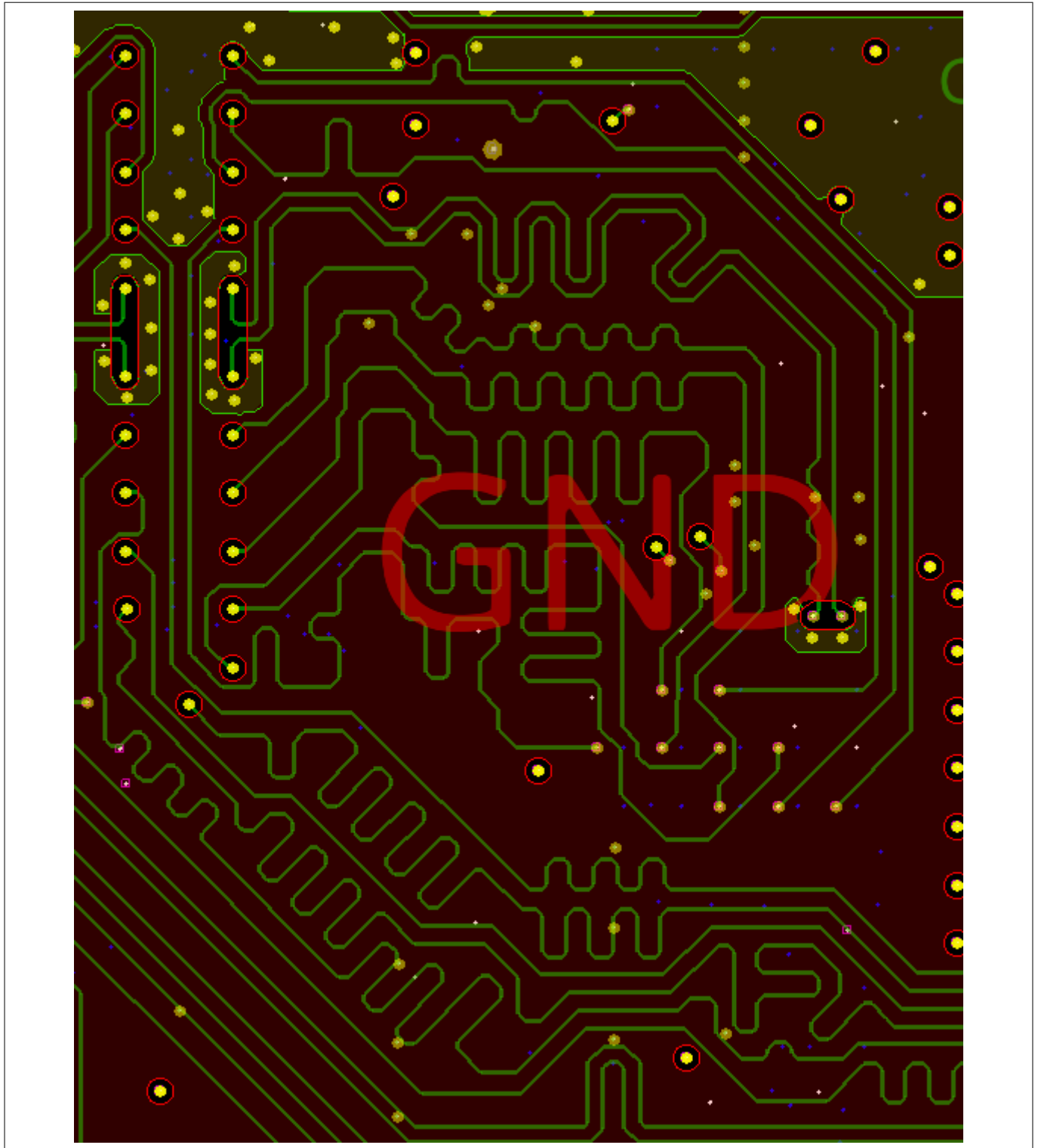


Figure 16 Reference plane for control impedance

If a critical length net is not routed on a layer adjacent to its reference plane layer, there will be significant EMI and crosstalk problems.

Get the stack-up from the manufacturer upfront or during the stating of the PCB design. Any violation on the return path and the signal will fail.

You should be clear about the edge-coupled offset strip line and edge-coupled coated microstrip patterns as this has a significant impact on the trace width for controlled impedance lines.

5 IPC class type and minimum drill and pad requirements

5 IPC class type and minimum drill and pad requirements

5.1 FBGA-220

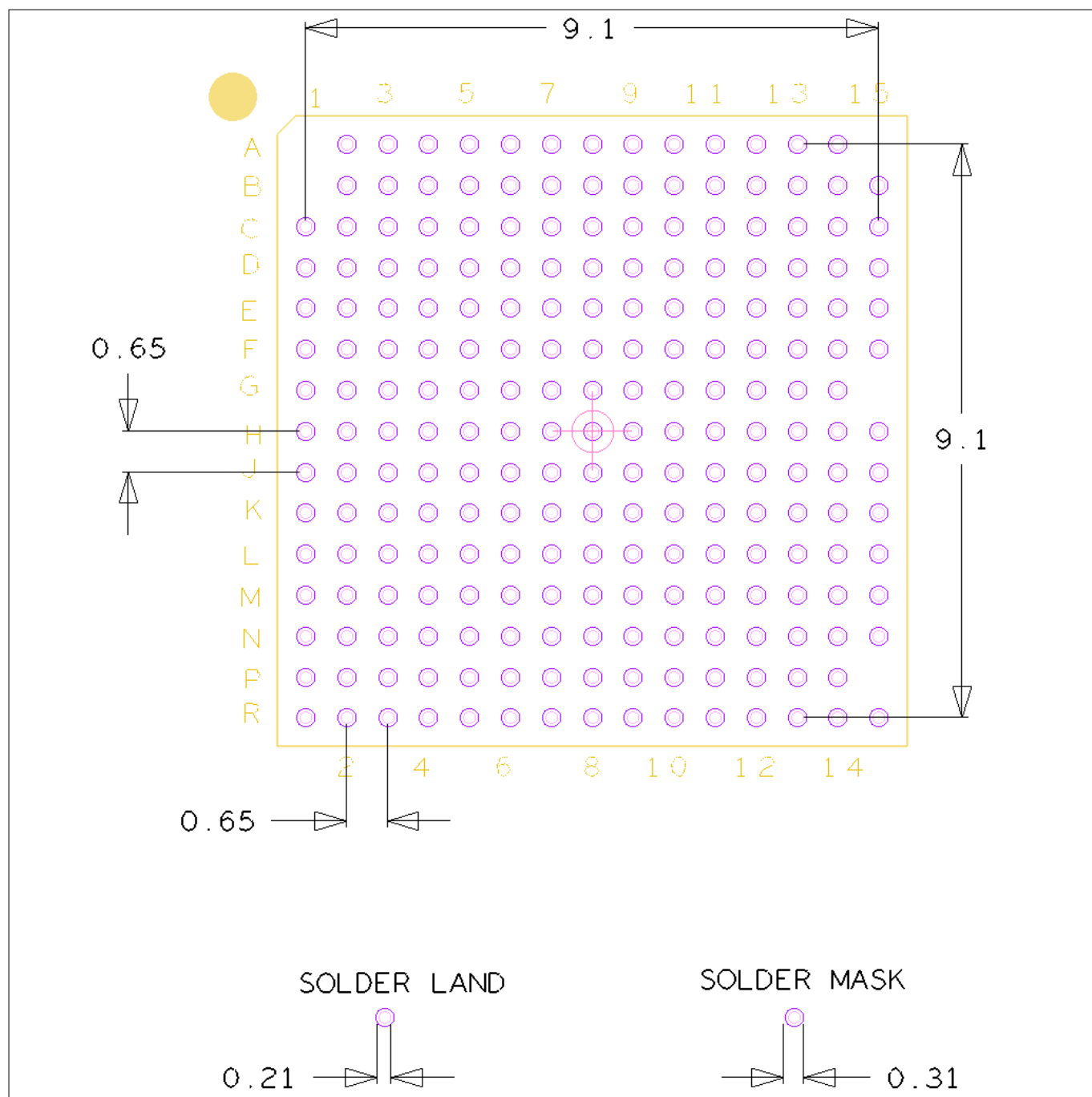


Figure 17 BGA 220 minimum drill and pad requirements

5 IPC class type and minimum drill and pad requirements

5.2 eWLB-235

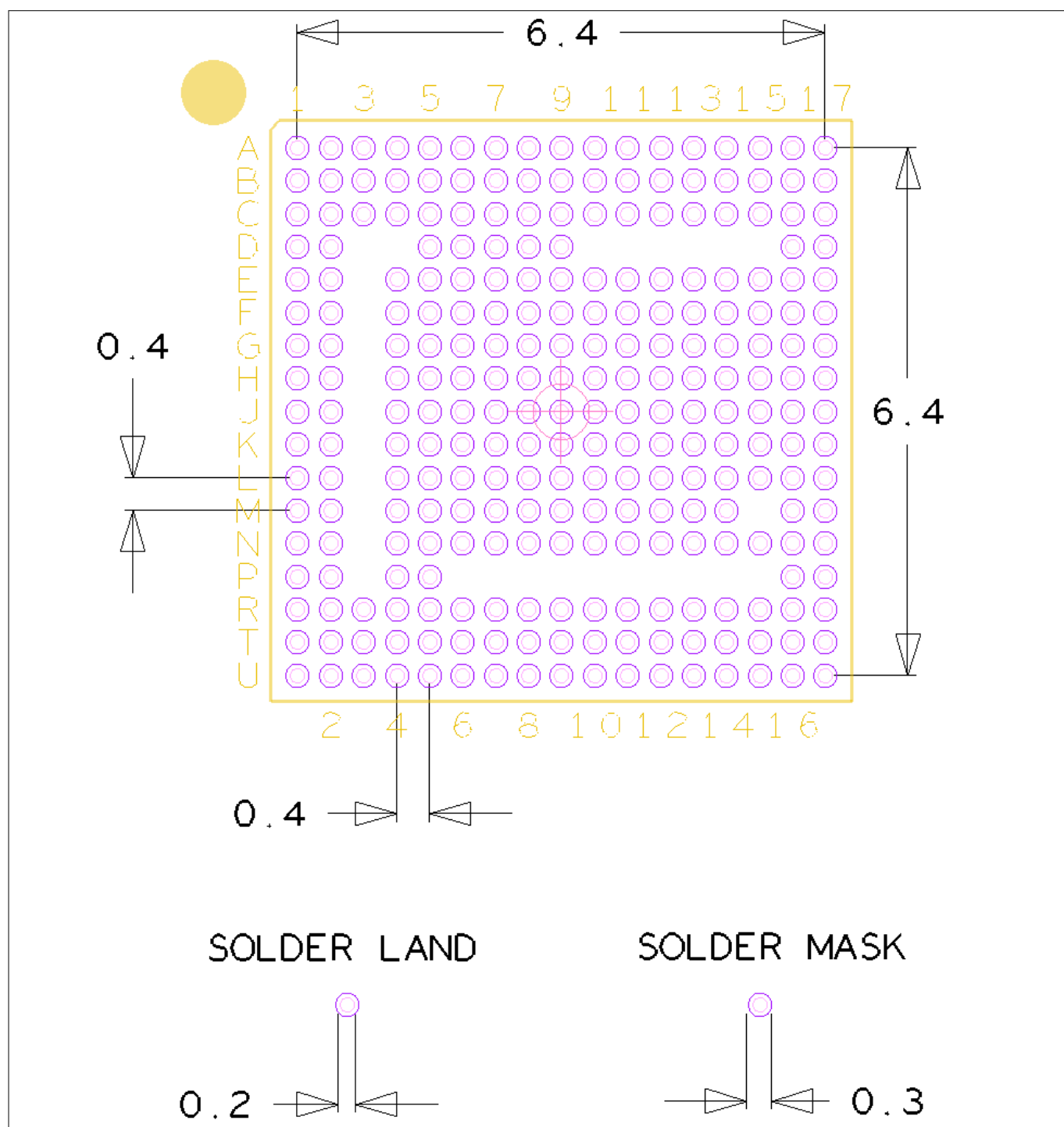


Figure 18 eWLB-235 minimum drill and pad requirements

5 IPC class type and minimum drill and pad requirements

5.3 WLB-154

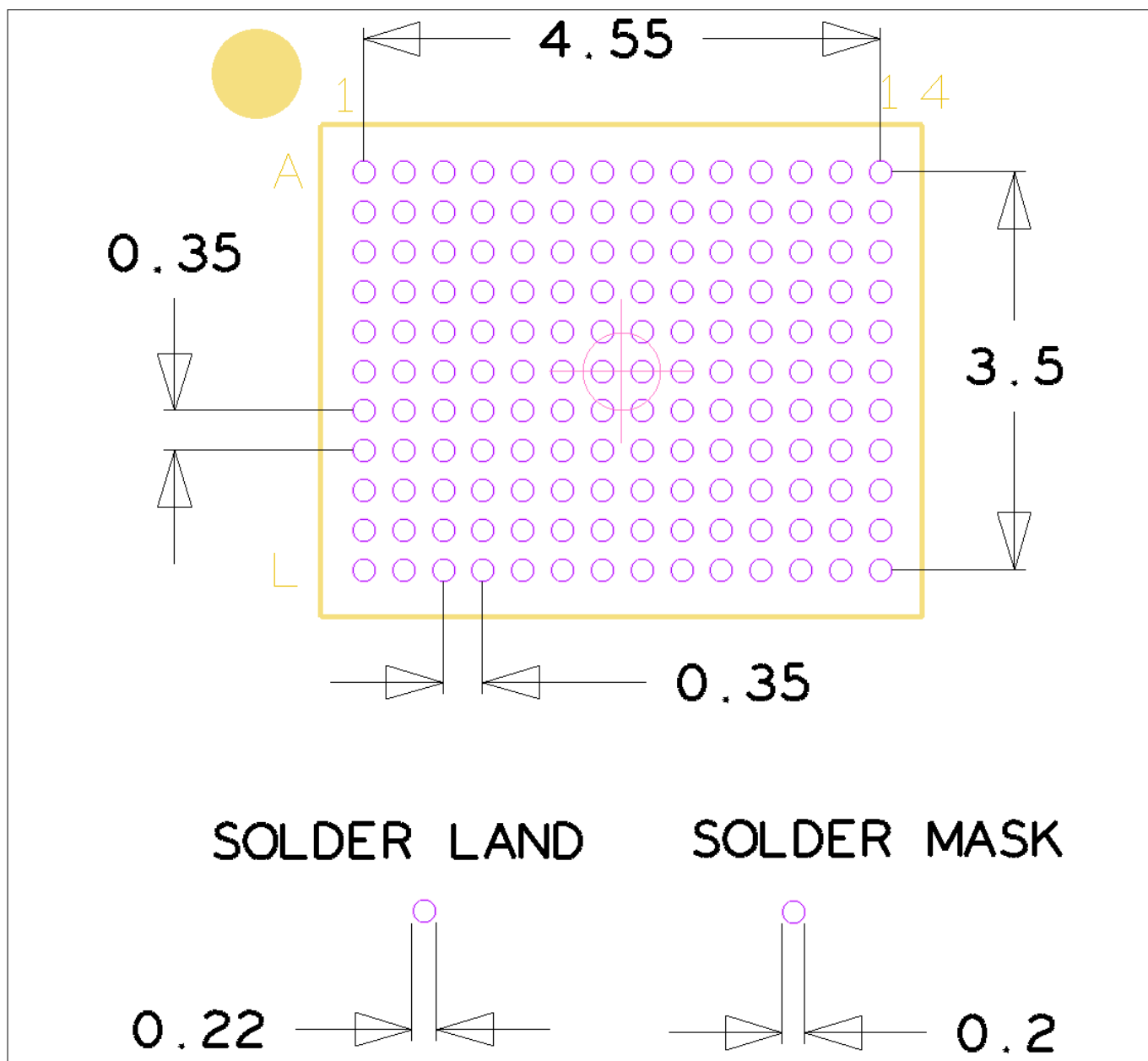


Figure 19 WLB-154 minimum drill and pad requirements

Note: All CAD source related files, symbol, and footprint in Altium, Cadence, and Pads format link will be provided later (Weblink).

6 Reference board breakout and layout recommendations

6 Reference board breakout and layout recommendations

6.1 Layout example summary

For mechanical dimension details see [Package types](#). The following examples describe some of the routing challenges such as stackup definition, via structure, GND, and power reference plane, minimum feature requirements -minimum trace width and clearance are solved for different PSOC™ BGA package products. Examples include figures of reference layouts for all the packages. In principle, these high-level values should be considered during the initial design phase to choose a suitable manufacturer for the PSOC™ BGA package products.

6.2 FBGA-220 - Breakout and routing example

This breakout uses a 10 mm x 10 mm size package, 0.65 mm pitch, FBGA-220 ball package in an 8-layer routing using through-via and stacked via pad of 9 mil and via drill of 4 mil technology. Flat surface at top land. This example utilizes a 3.5/3.0 mil trace width/space, other through via the pad of 16 mils, and via drill of 8 mils.

The following sections show the different layers of the of the reference board.

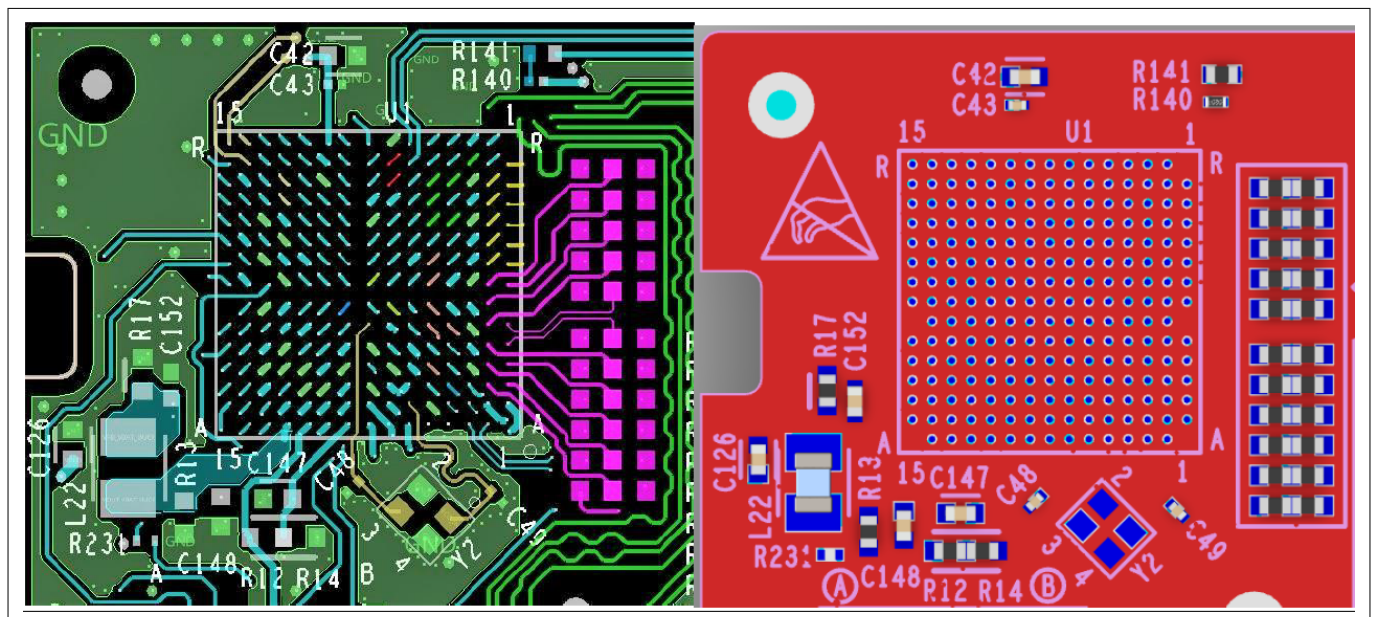


Figure 20 Top placement

6.2.1 Layer 1: Component placement

Layer 1 shows how components are placed around the FBGA-220 device in the top layer. The crystal area, critical routing section, and some ground isolation areas are identified and shown in the following sections.

6 Reference board breakout and layout recommendations

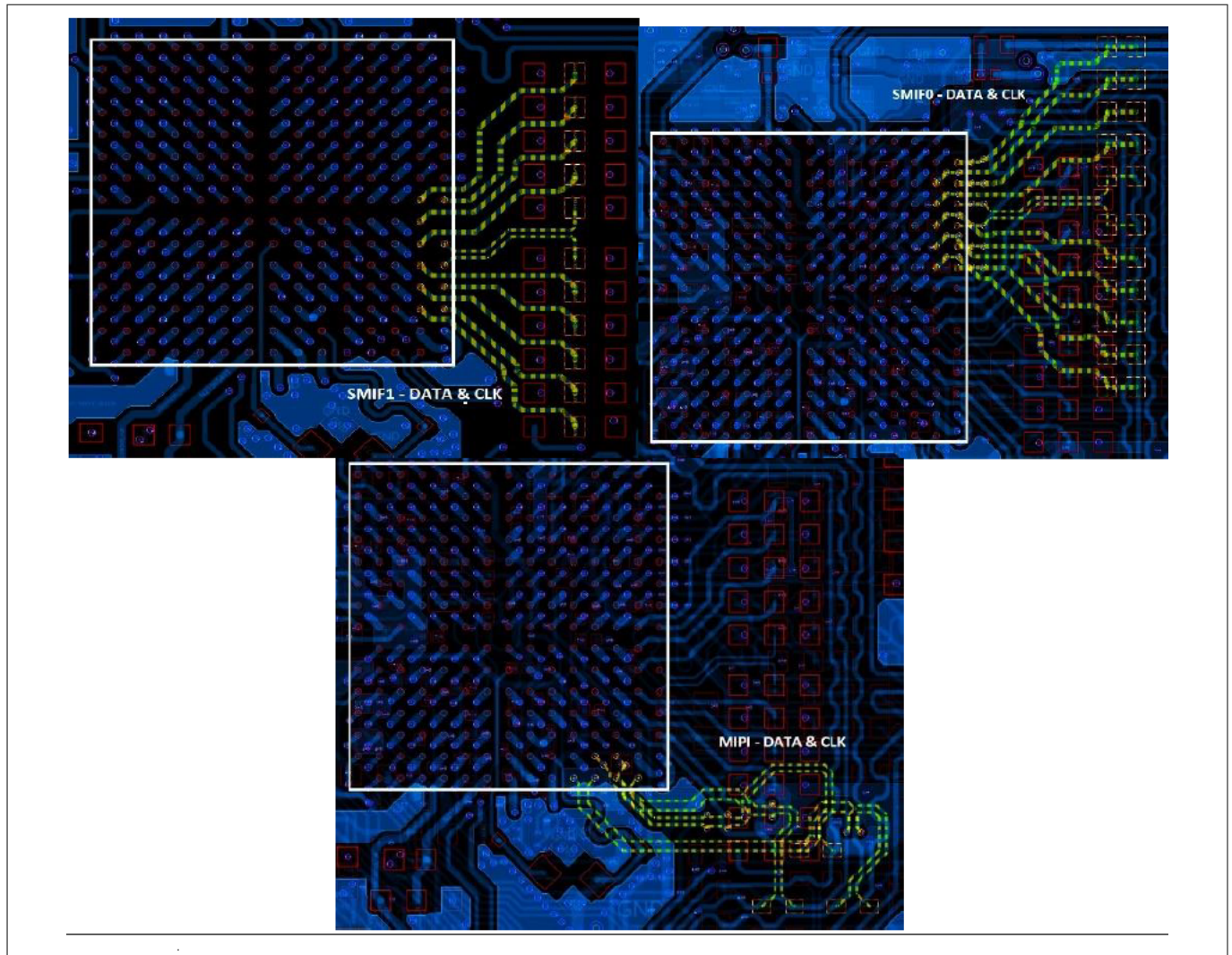


Figure 21 **Layer 1**

The figure shows the top layer SMIF 0 and 1 signal break out routing till the termination reference board. Also, MIPI data and clock signals routing on Layer 1 shows how components are placed around the FBGA-220 device.

6.2.2 **Layer 2: GND1 reference**

Layer 2 (ground plane) shows the solid copper plane under the FBGA-220 device.

6 Reference board breakout and layout recommendations

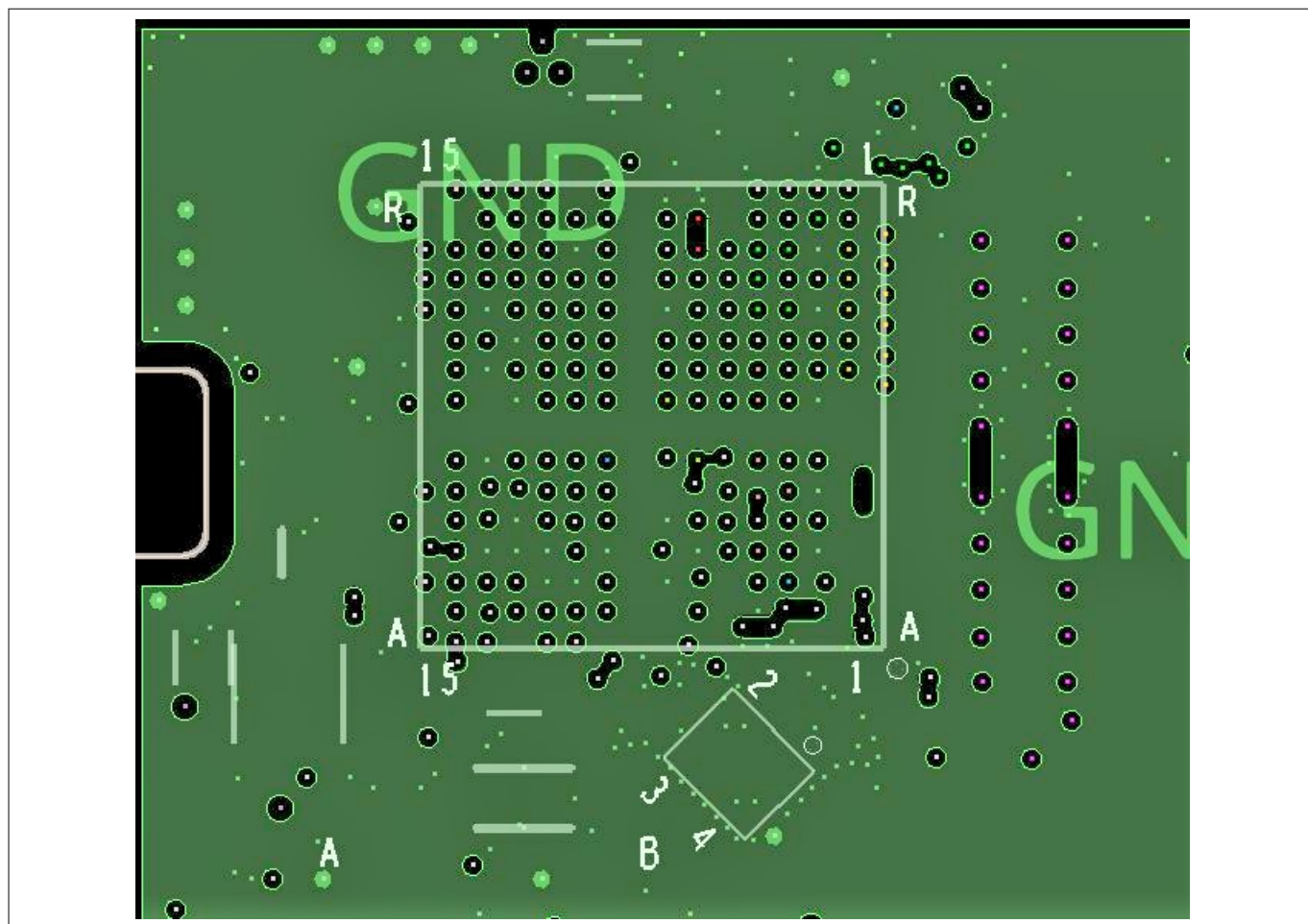


Figure 22 **Layer 2**

6.2.3 **Layer 3: Signal 1**

Layer 3 (signal) shows how critical controlled impedance and non-critical signals are routed around the FBGA-220 device.

6 Reference board breakout and layout recommendations

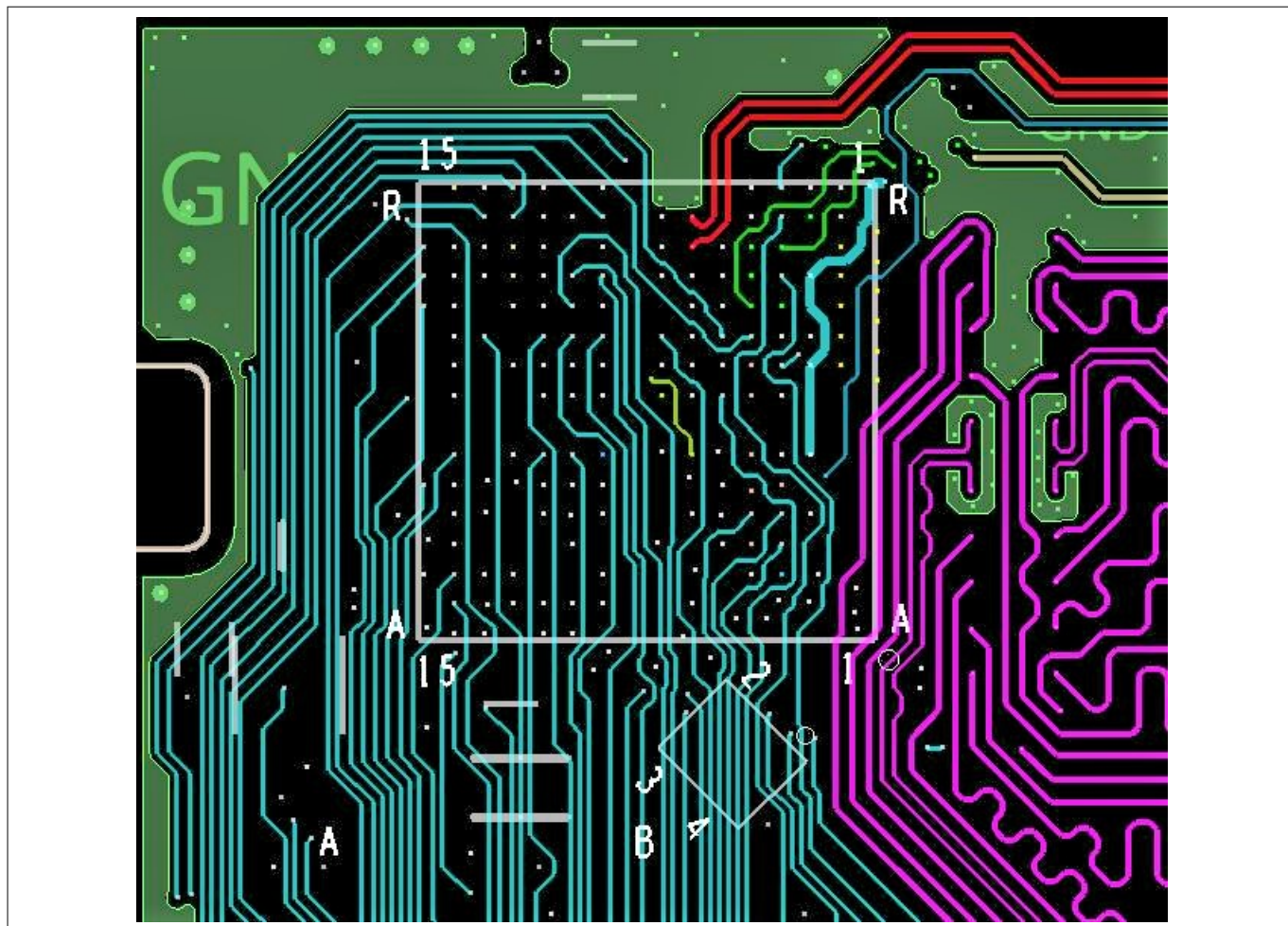


Figure 23 **Layer 3**

6.2.4 **Layer 4: PWR/Signal**

Layer 4 (power/signal) shows few non-critical signals that are routed around the FBGA-220 device and also a few power signals that are routed with increased trace width.

6 Reference board breakout and layout recommendations

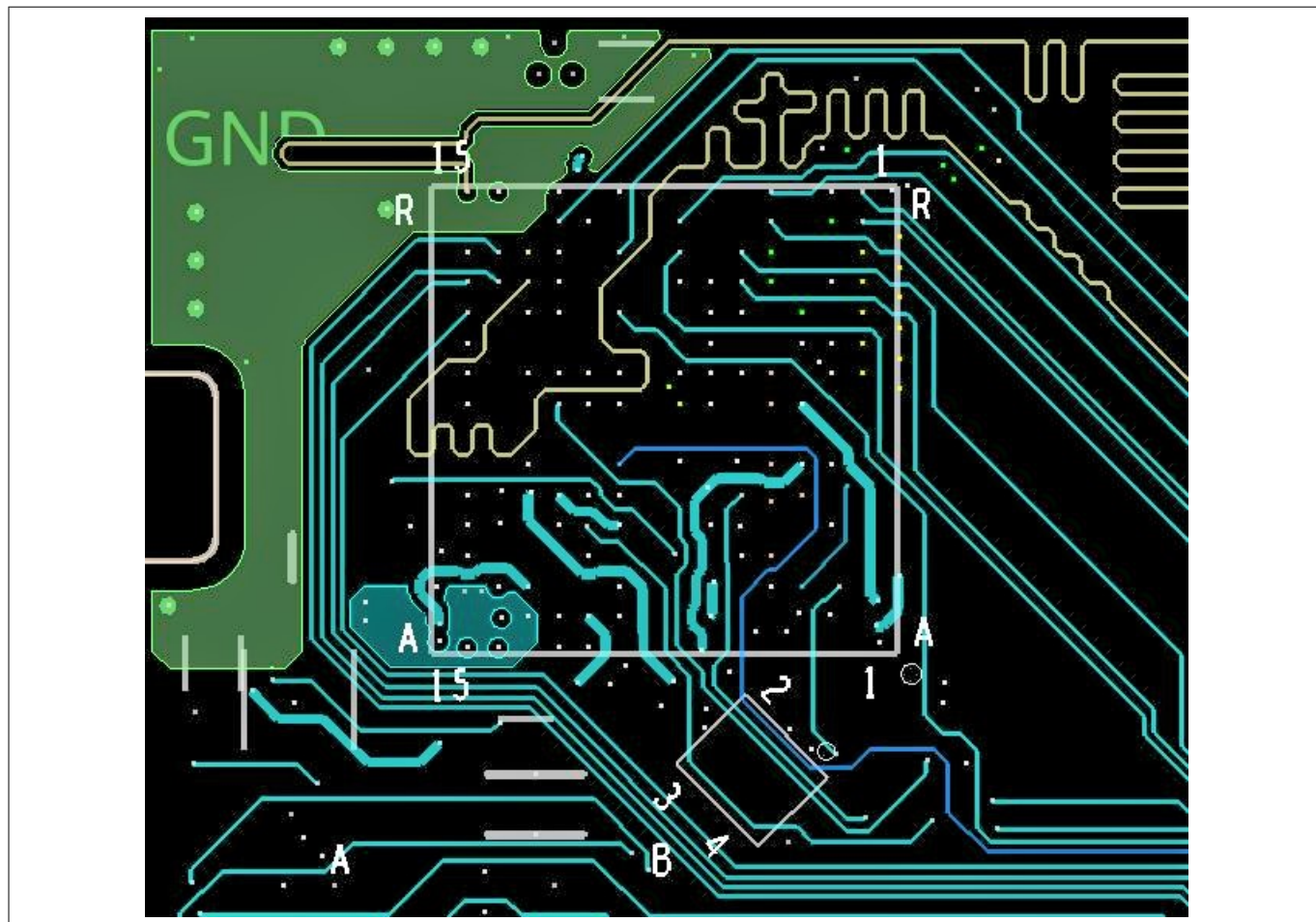


Figure 24 **Layer 4**

6.2.5 **Layer 5: PWR**

Layer 5 (power) shows how all power rails are connected to support large current and low current carrying signals are routed with adequate trace width around the FBGA-220 device.

6 Reference board breakout and layout recommendations

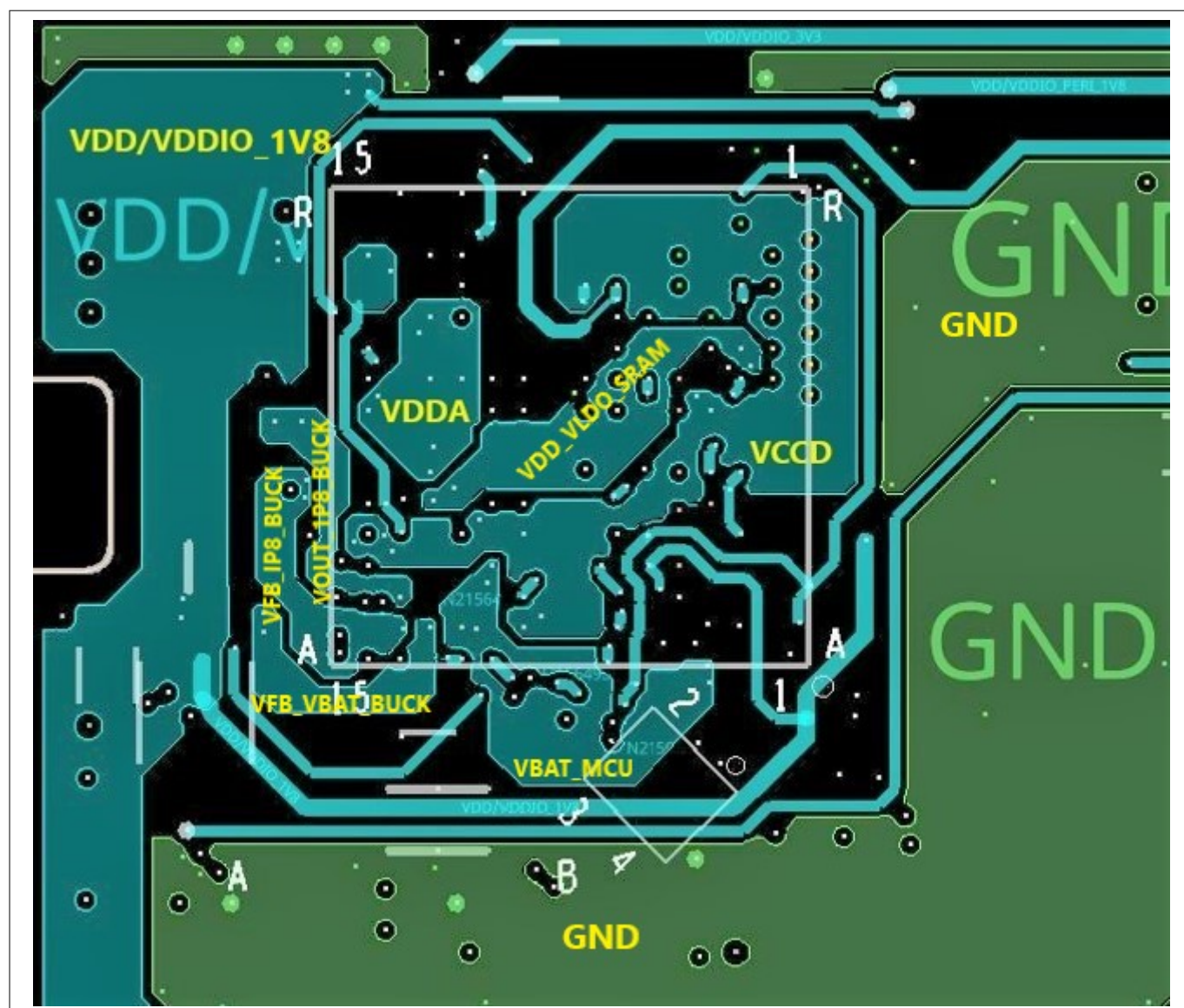


Figure 25 Layer 5

6.2.6 Layer 6: Signal 2

Layer 6 (signal) shows how critical controlled impedance and non-critical signals are routed around the FBGA-220 device.

6 Reference board breakout and layout recommendations

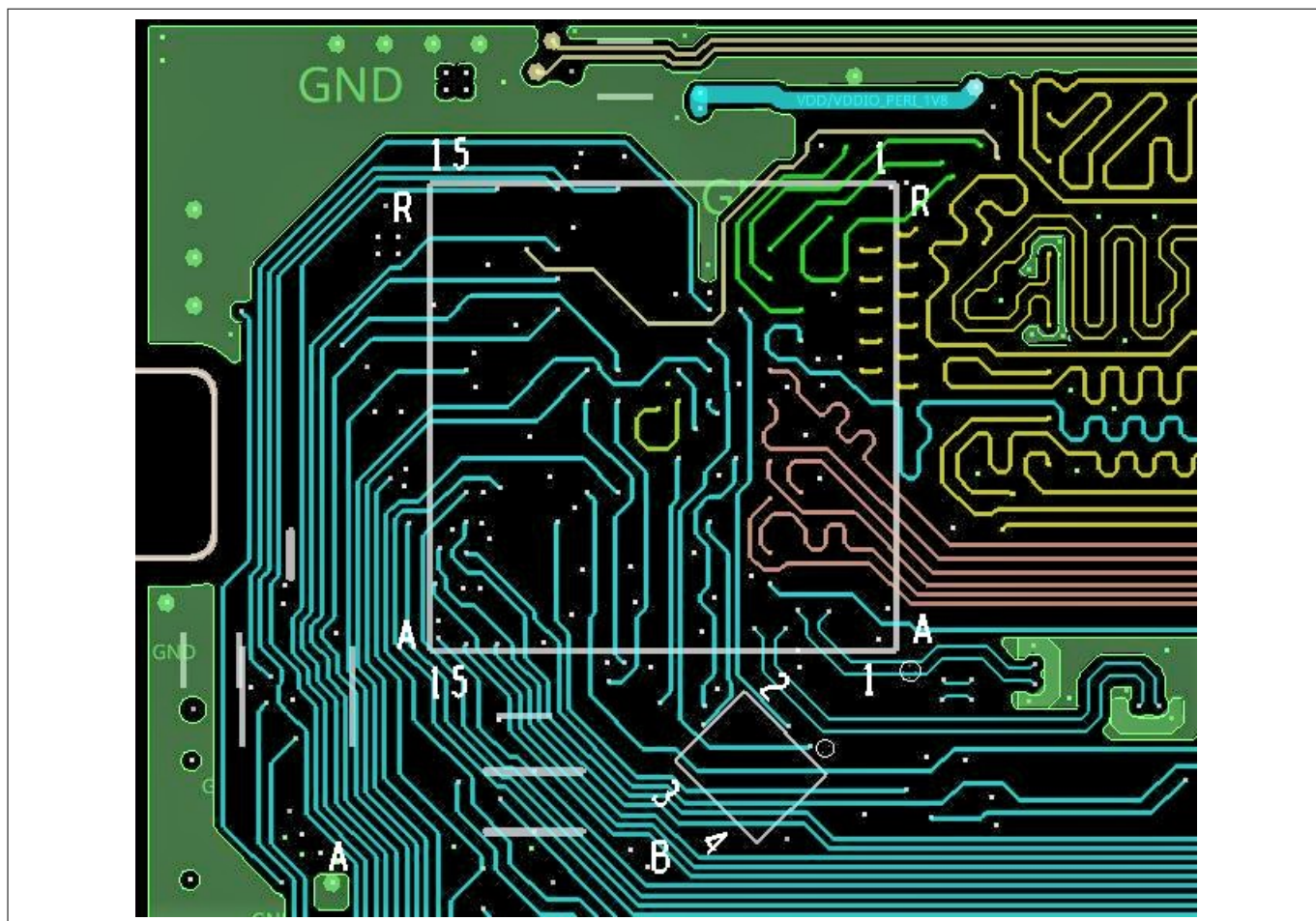


Figure 26

Layer 6

6.2.7 Layer 7: GND2 reference

Layer 7 (ground plane) shows how solid copper plane is routed under the FBGA-220 device to ensure layer 6 high speed-controlled impedance signals.

6 Reference board breakout and layout recommendations

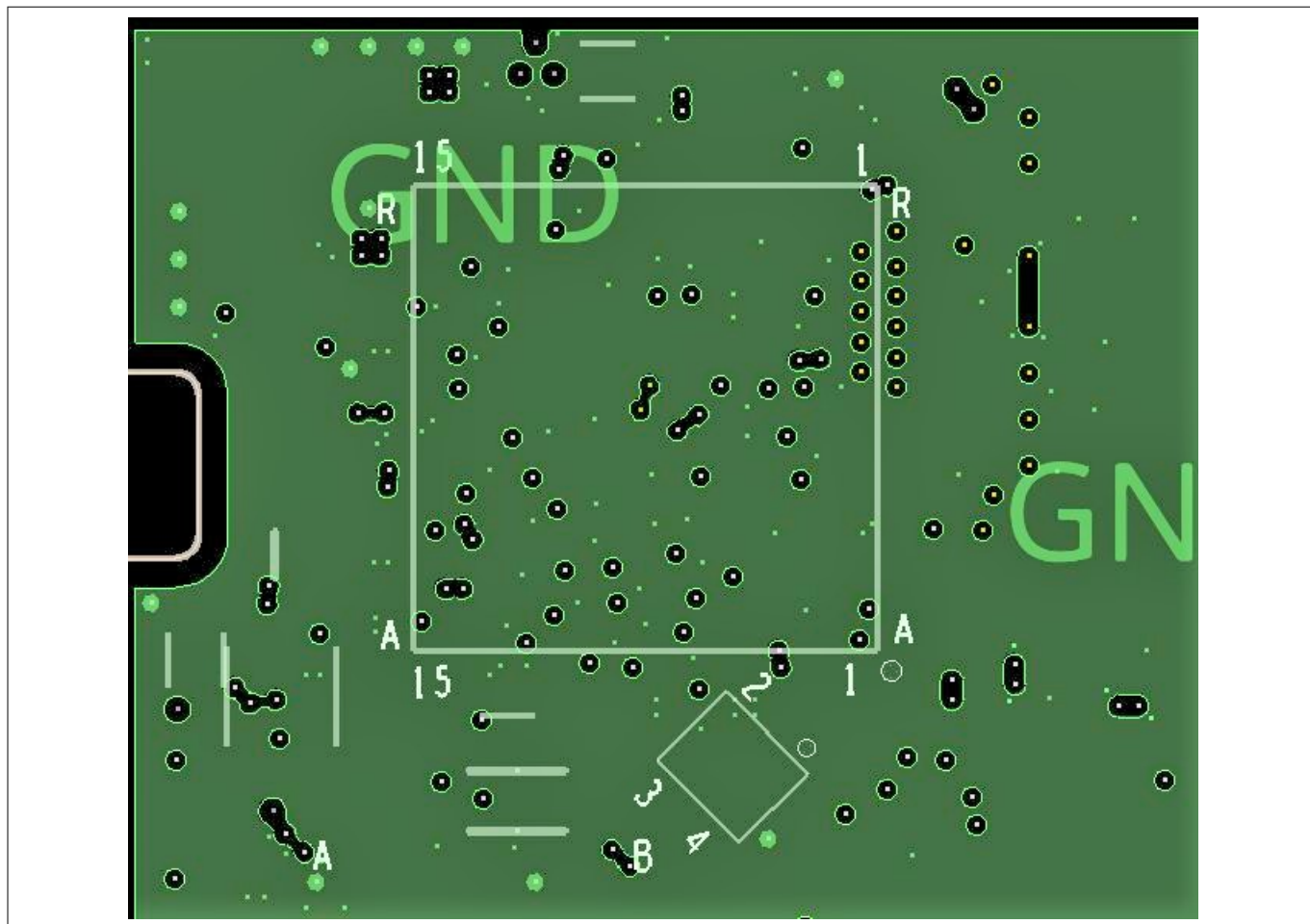


Figure 27 Layer 7

6.2.8 Bottom layer

Layer 8 (bottom layer) shows how components are placed around the bottom of the FBGA-220 device. The crystal area, critical routing section, and some power, ground isolation areas are identified.

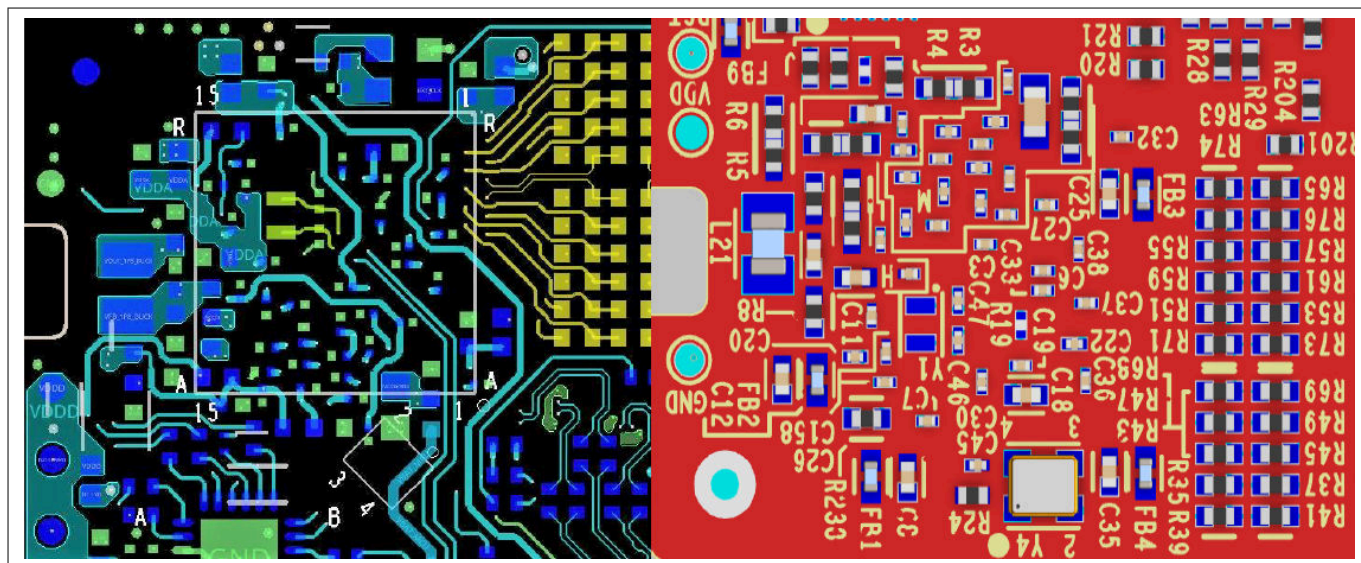
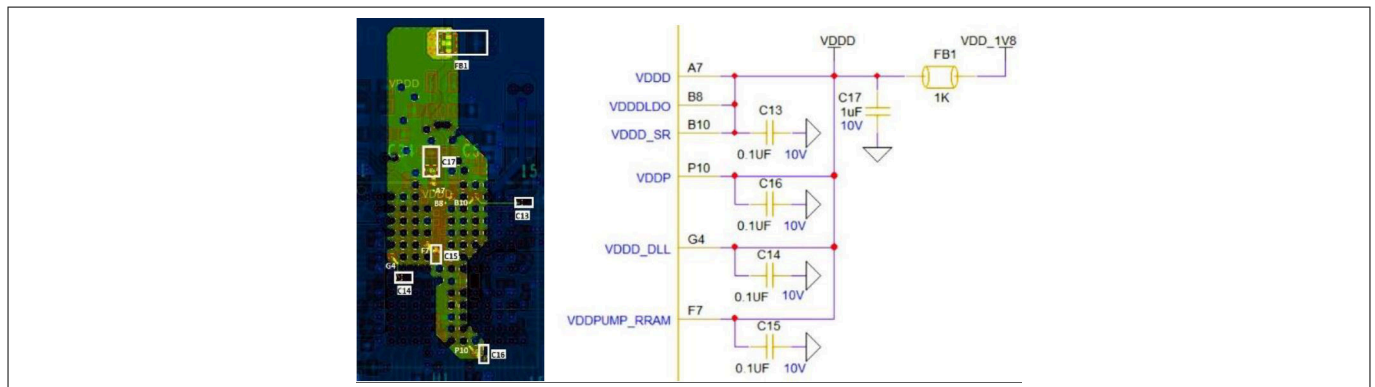


Figure 28 Layer 8

The routing and decoupling capacitor placement of key power rails such as VDD, VBAT, VDDIO, VDDIO_SMIF are shown in the following figures.



002-36517 Rev. *B
2025-09-19

6 Reference board breakout and layout recommendations

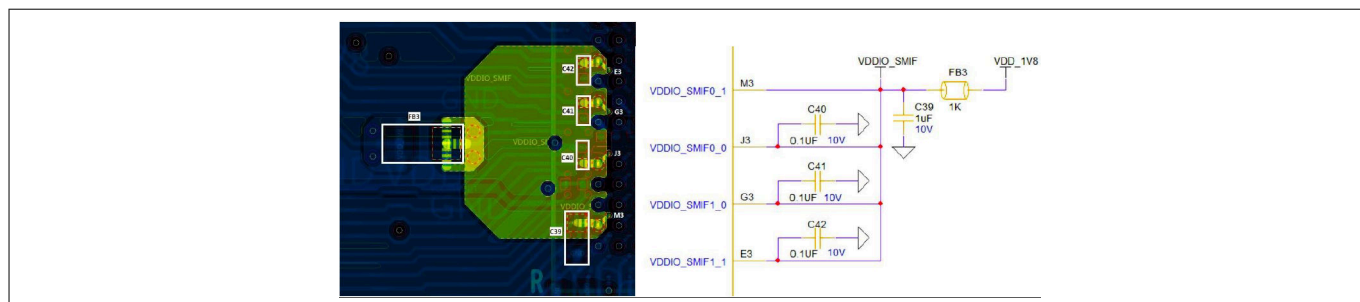


Figure 32 VDDIO_SMIF

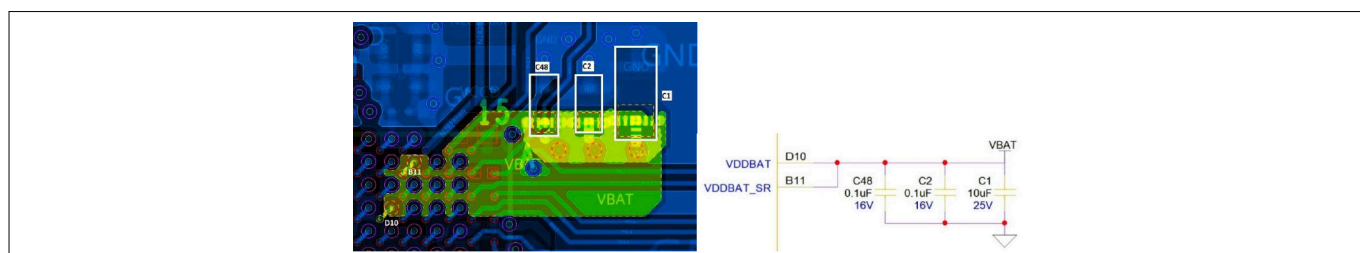


Figure 33 VBAT

6.2.9 PCB stack-up and vias recommendation

This PCB stack-up construction is decided based on the component package considering signal trace density and impedance requirements for high-speed peripherals. This leads to a multilayer PCB with dedicated ground and power supply planes. Solid copper planes allow designers to keep the device ground and power connections short.

Further, the ground plane offers low inductance return paths for the high-speed signals.

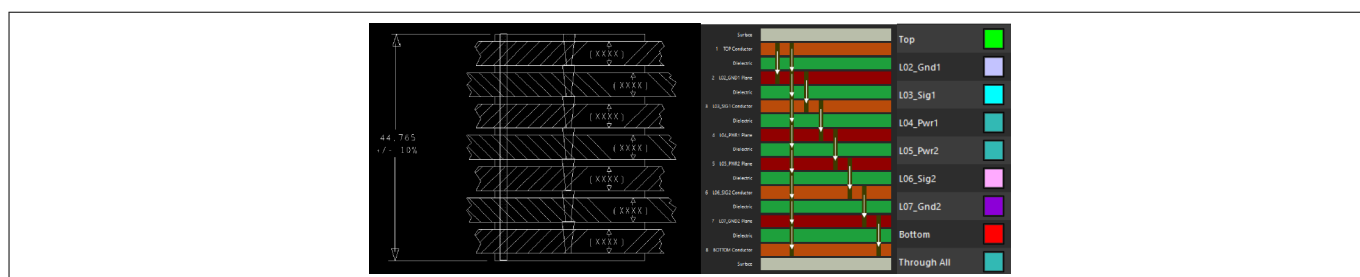


Figure 34 PCB stack-up and vias

To meet signal integrity and performance requirements, a minimum of eight-layer stack-up is recommended for implementing end-user systems. The following layer stack-ups are recommended for eight-layer boards, although other options are possible. Within a PCB it may be desirable to run traces using different methods, microstrip vs. strip line, depending on the location of the signal on the PCB. For example, it may be desirable to change layer stacking where a minimum peripheral or limited functionality is used.

PCB designers must figure out the number of layers required to fan out a FBGA-220. Consequently, the designer must determine on which layers the critical signals are routed and the number of power and ground layers required. All these parameters help determine the number of layers in the stack.

6.2.10 HDI vias routing:

HDI-type via interconnect is used for this complex board break out. This has the following advantages and disadvantages.

6 Reference board breakout and layout recommendations

Advantages

- Highly routable board
- Minimum layers

Disadvantages

- Extra steps in the processing flow due to special drilling and plating laminations.

6.3 eWLB-235 - Ball BGA breakout and routing example

This breakout uses a 7.5 mm x 7.5 mm size package, 0.4 mm pitch, 235-ball BGA package in an 8-layer routing using via-in-pad technology. All vias are stacked. Flat surface is at the top layer. This reference board example utilizes a 2.2/2.2 mil trace width/space, escape via pad of 9 mil and via drill of 4 mil.

6.3.1 Layer1: Top placement

Layer 1 (top layer) shows how components are placed around the top of the eWLB-235 device. The crystal area, critical routing section, and some ground isolation areas are identified.

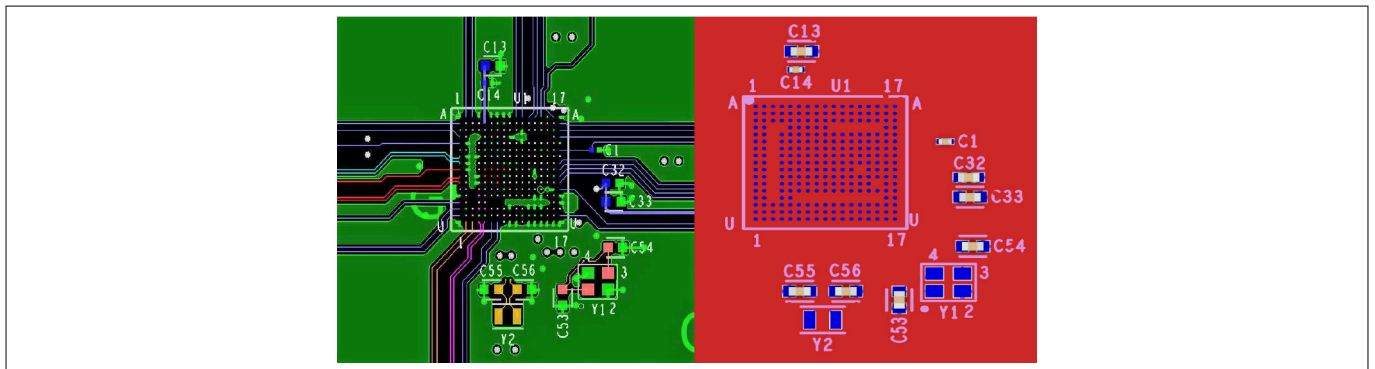


Figure 35 eWLB-235 - Layer 1

6.3.2 Layer 2: GND1 reference

Layer 2 (ground plane) shows the solid copper plane is routed under the eWLB-235 device.

6 Reference board breakout and layout recommendations

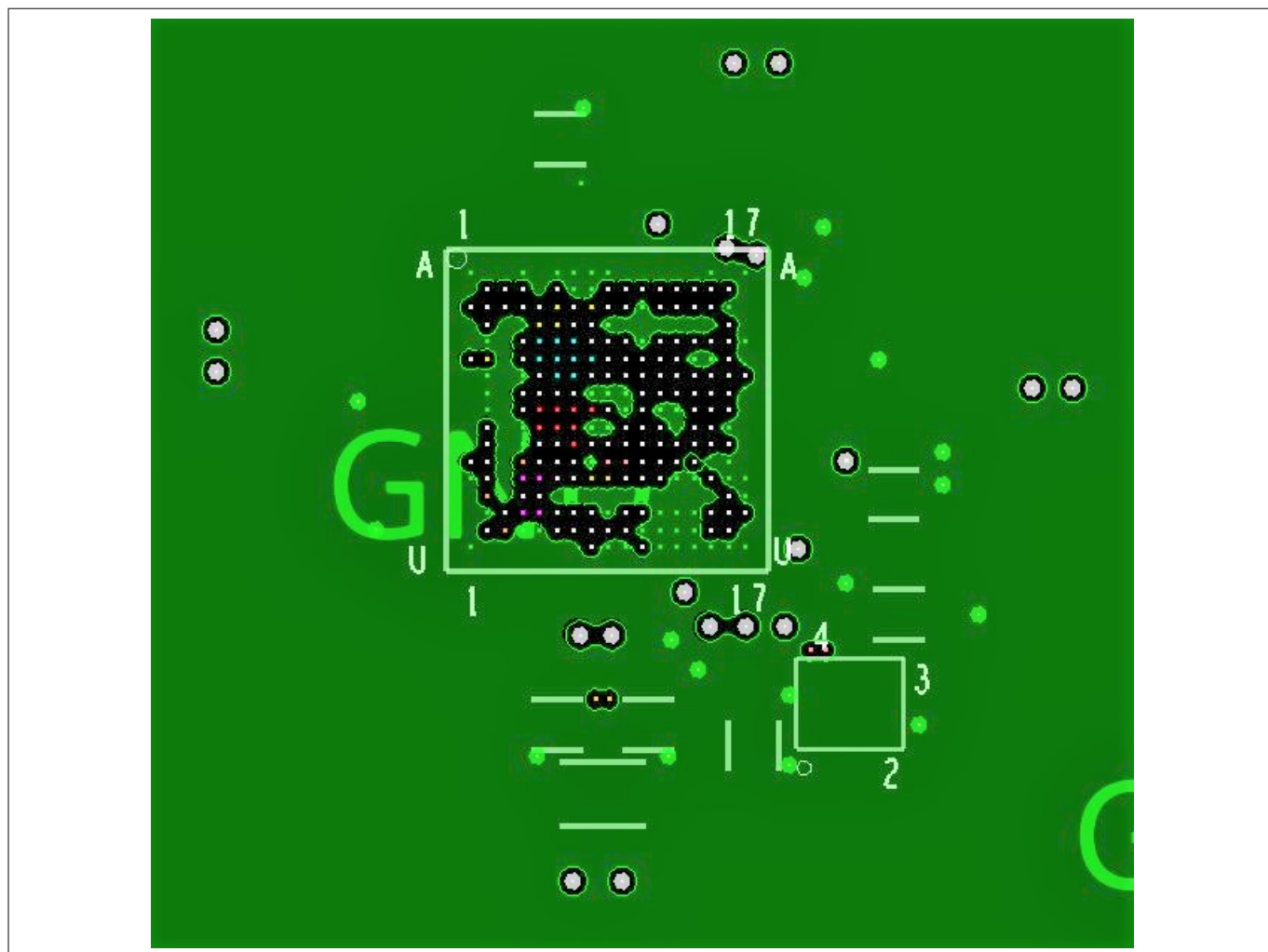


Figure 36 eWLB-235 - Layer 2

6.3.3 Layer 3: Signal 1

Layer 3 (signal) shows how critical controlled impedance and non-critical signals are routed around the eWLB-235 device.

6 Reference board breakout and layout recommendations

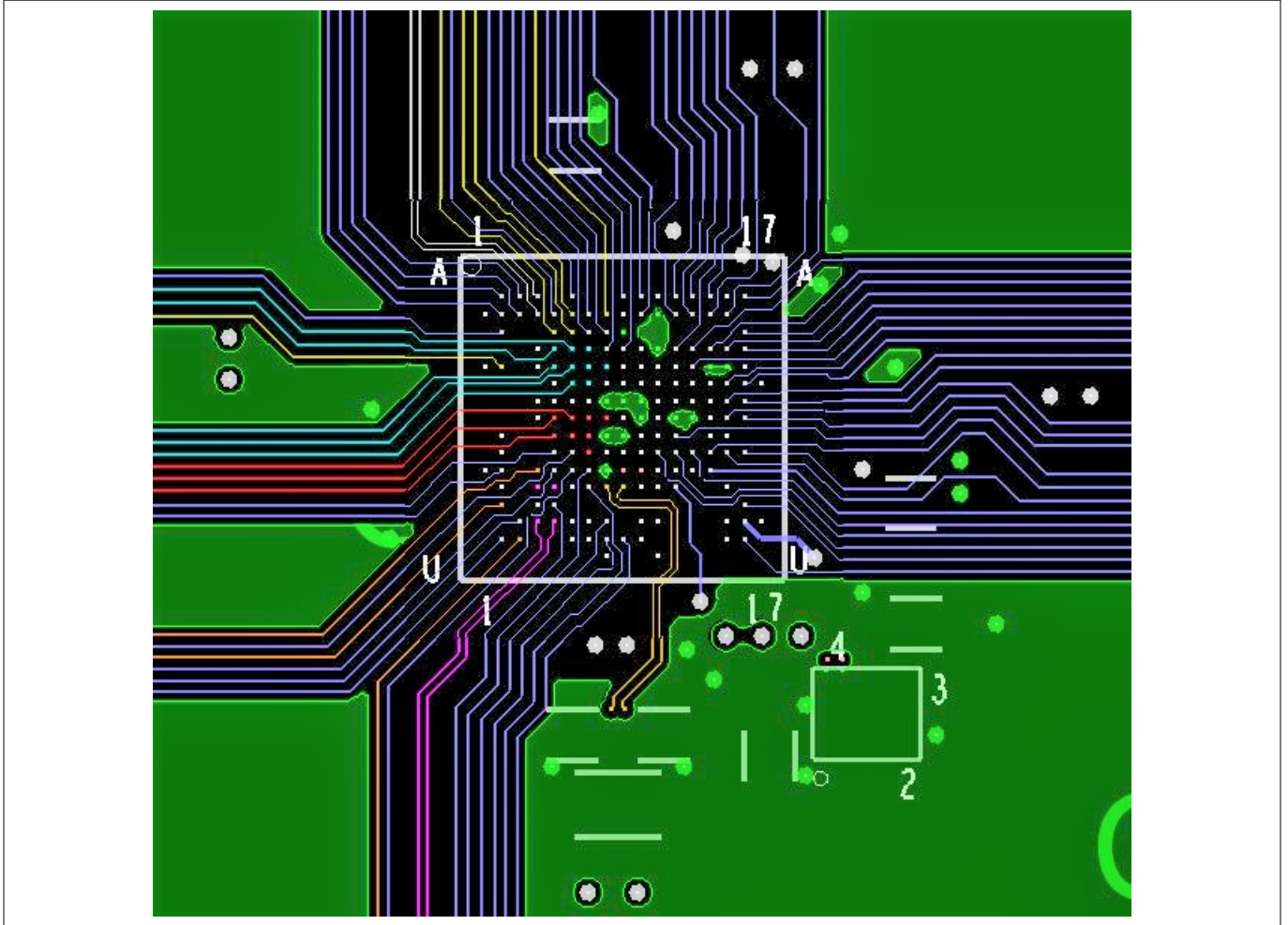


Figure 37 **eWLB-235 - Layer 3**

6.3.4 Layer 4: PWR

Layer 4 (power) shows how all power rails are connected to support large currents and low current power signals are routed with adequate trace width around the eWLB-235 device.

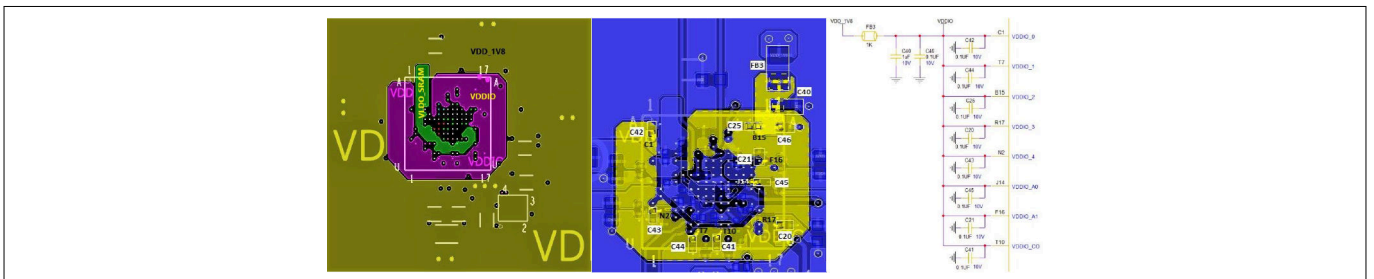


Figure 38 **eWLB-235 - Layer 4**

6.3.5 Layer 5: PWR

Layer 5 (power) shows how all power rails are connected to support high current and low current power signals are routed with adequate trace width around the eWLB-235 device.

6 Reference board breakout and layout recommendations

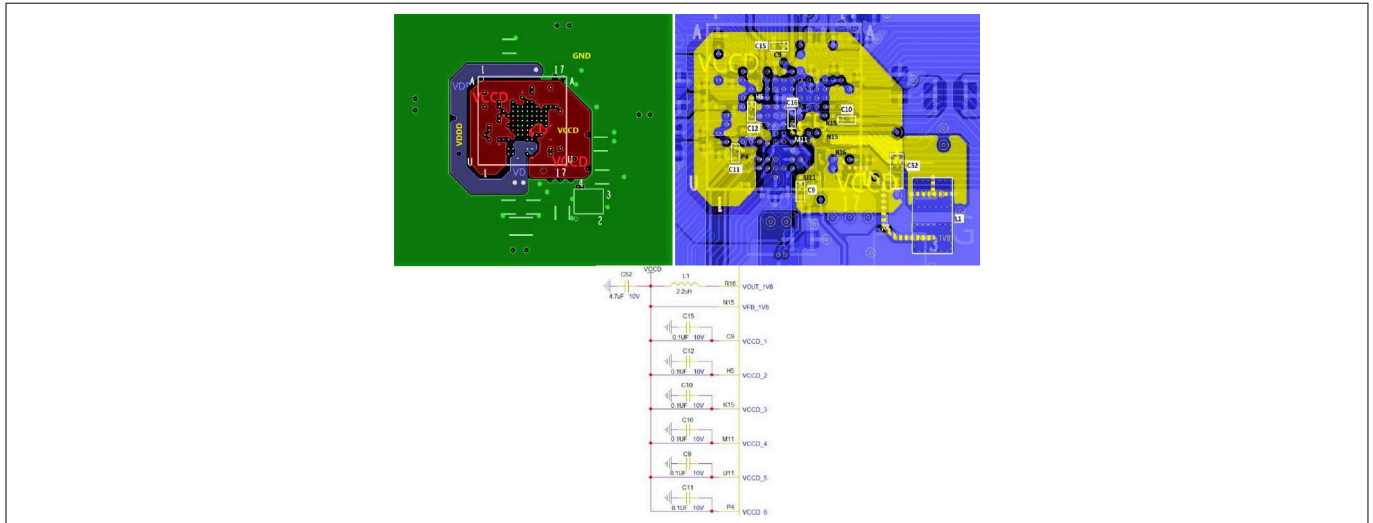


Figure 39 eWLB-235 - Layer 5: High current

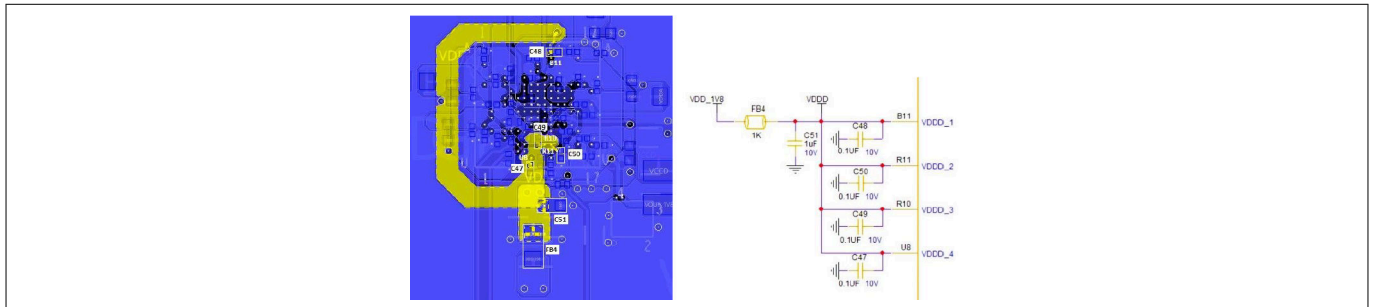


Figure 40 eWLB-235 - Layer 5: Low current

6.3.6 Layer 6: Signal 2

Layer 6 (signal) shows how critical controlled impedance and non-critical signals are routed around the eWLB-235 device.

6 Reference board breakout and layout recommendations

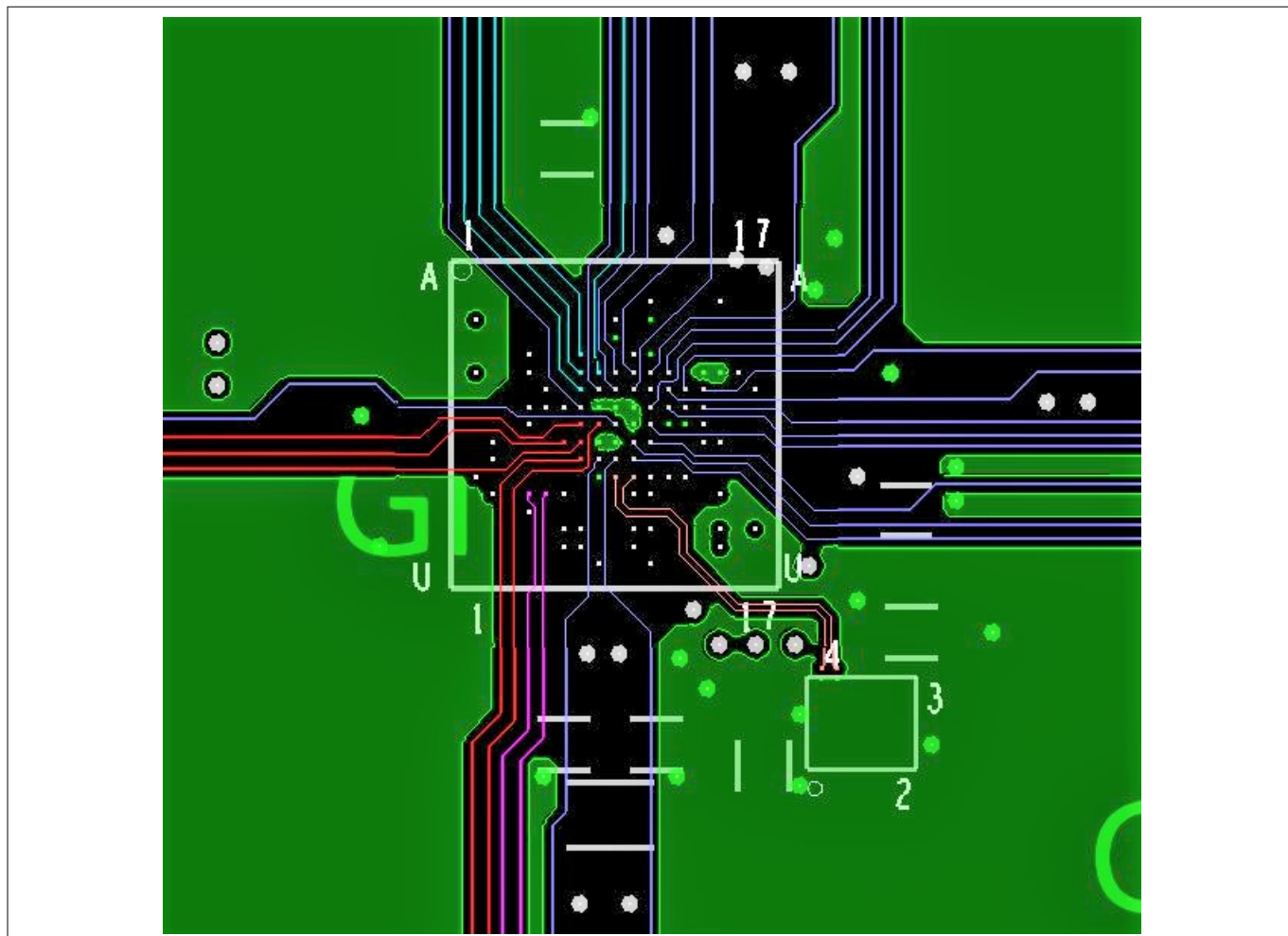


Figure 41 eWLB-235 - Layer 6

6.3.7 Layer 7: GND2 reference

Layer 7 (ground plane) shows how solid copper plane under the eWLB-235 device.

6 Reference board breakout and layout recommendations



Figure 42 eWLB-235 - Layer 7

6.3.8 Bottom layer

Layer 8 (bottom layer) shows how components are placed around the bottom of the FBGA-220 device. The crystal area, critical routing section, and some ground isolation areas are identified.

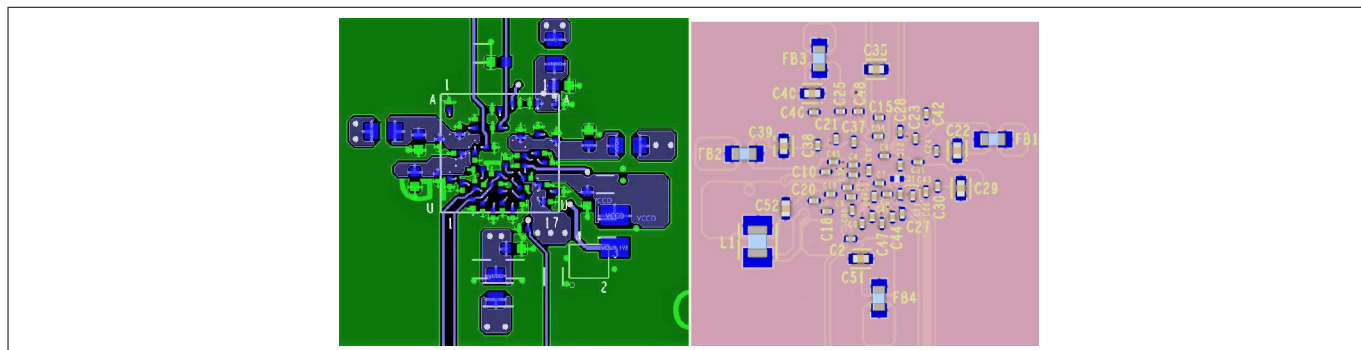


Figure 43 eWLB-235 - Layer 8

6 Reference board breakout and layout recommendations

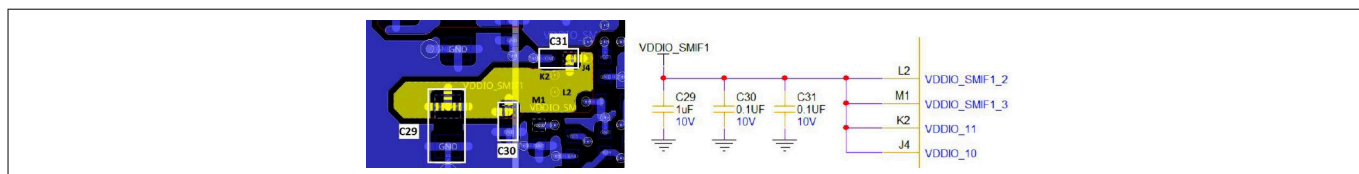


Figure 44 VDDIO schematic section

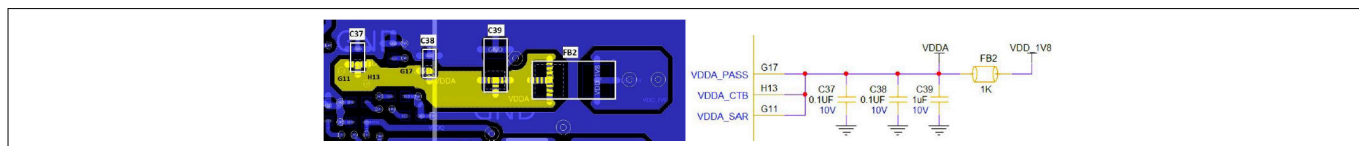


Figure 45 **VDDA schematic section**

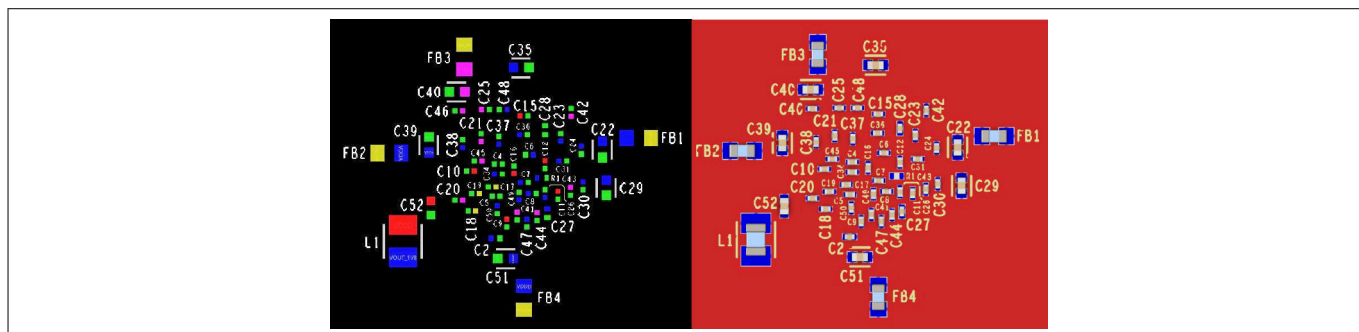


Figure 46 **eWLB-235 – Bottom layer silkscreen**

6.3.9 PCB stack-up and vias recommendation

This PCB stake up construction decided based on the component package, considering signal trace density and impedance requirements for high-speed peripherals, it leads to multilayer PCB with dedicated ground and power supply planes. Solid copper planes allow designers to keep the device ground and power connections short.

Further, the ground plane offers low inductance return paths for the high-speed signals.

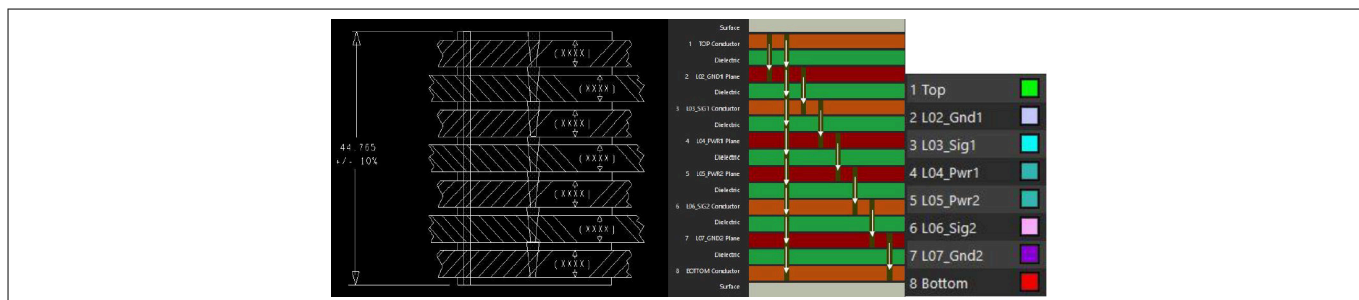


Figure 47 **PCB stack-up and vias**

This PCB stake up construction is decided based on the component package, considering signal trace density and impedance requirements for high-speed peripherals, it leads to multilayer PCB with dedicated ground and power supply planes. Solid copper planes allow designers to keep the device ground and power connections short. Further, the ground plane offers low inductance return paths for the high-speed signals.

To meet signal integrity and performance requirements minimum eight-layer stack-up is recommended for implementing end-user systems. The following layer stack-ups are recommended for eight-layer boards, although other options are possible. Within a PCB it may be desirable to run traces using different methods,

6 Reference board breakout and layout recommendations

microstrip vs. strip line, depending on the location of the signal on the PCB. For example, it may be desirable to change layer stacking where a minimum peripheral or limited functionality is used.

6.4 WLB-154 – Ball BGA breakout and routing example

This breakout uses a 5.3 mm x 4.3 mm size package, 0.35 mm pitch, 154-ball BGA package in a 6-layer routing using via-in-pad technology. All Staked vias. Flat surface at top land. This reference board example utilizes a 2.8/2.8 mil trace width/space, escape via the pad of 9/12 mil, and via drill of 4/6 mil.

6.4.1 Layer 1: Top placement

Layer 1 (top layer) shows how components are placed around the top of the WLB-154 device. Critical routing section, and some ground isolation areas are also identified.

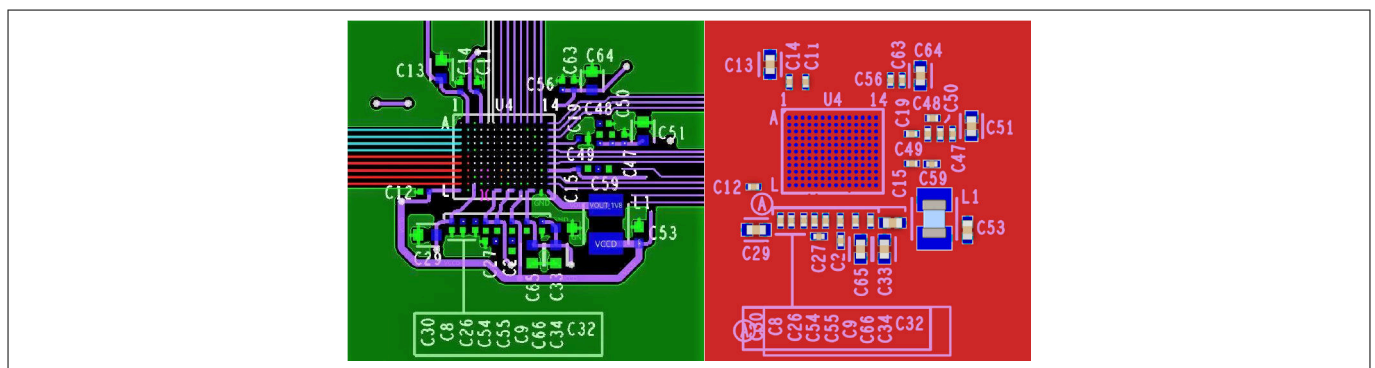


Figure 48 WLB-154 – Layer 1

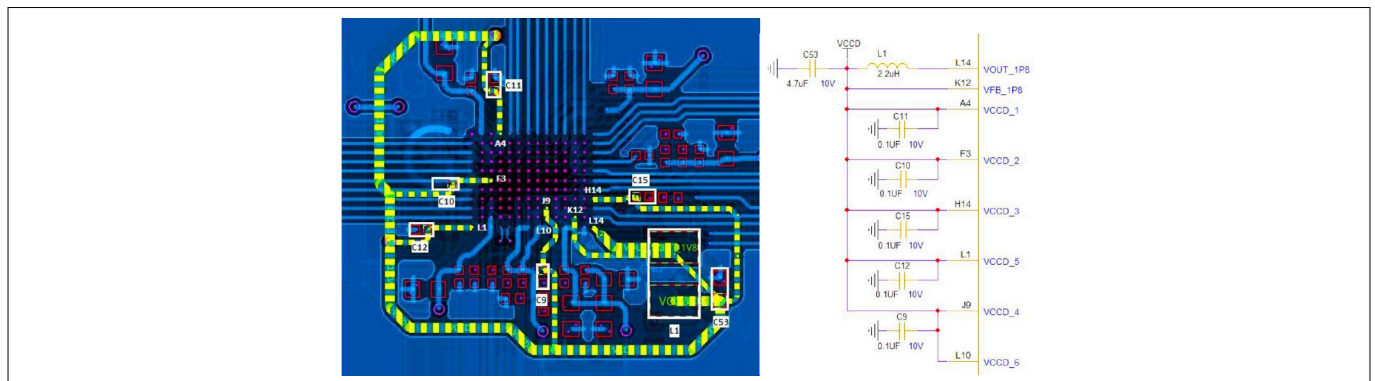


Figure 49 VCCD section layout and schematic

6.4.2 Layer 2: GND1 reference

Layer 2 (ground plane) shows the solid copper plane under the WLB-154 device.

6 Reference board breakout and layout recommendations

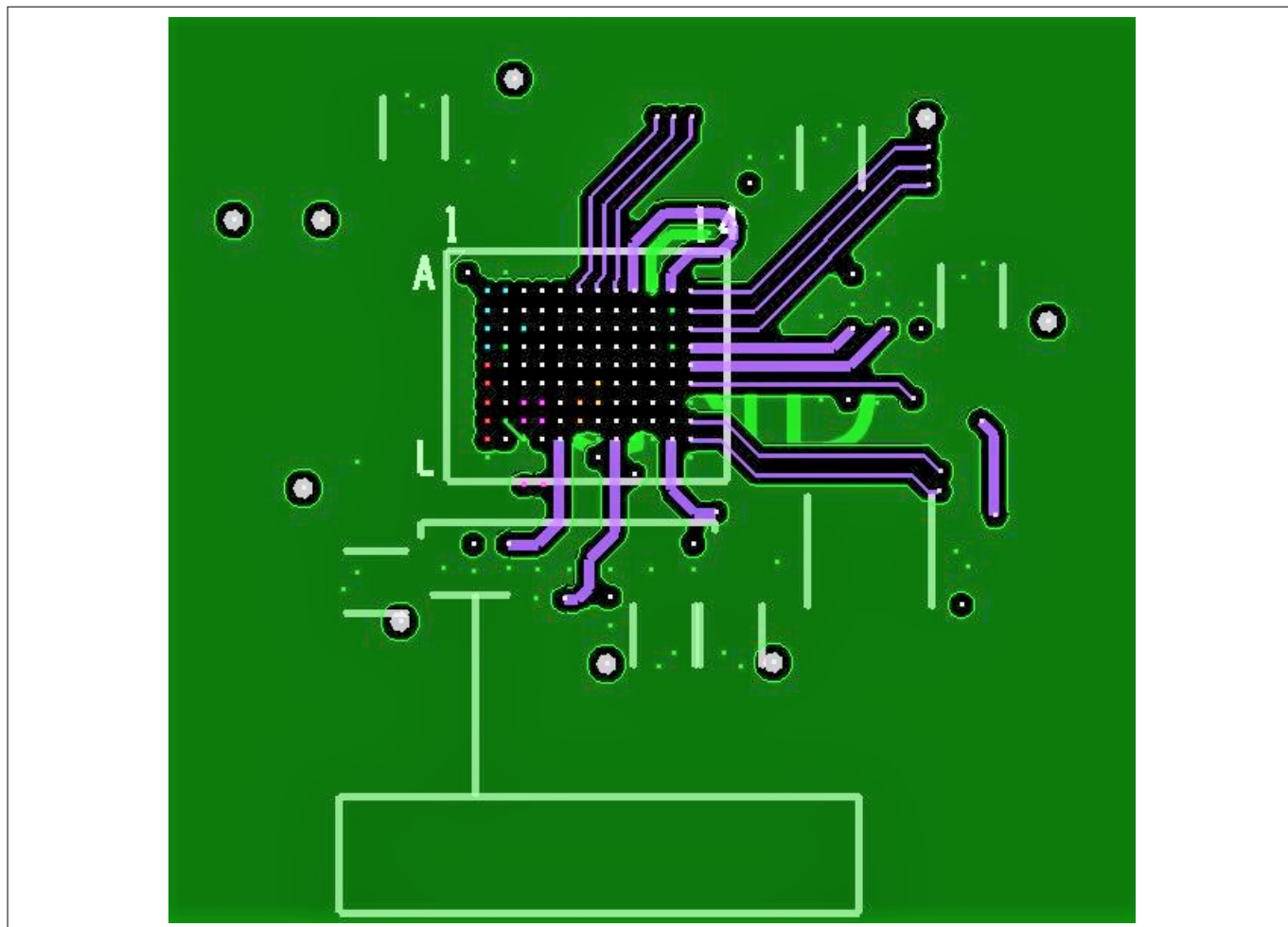


Figure 50 **WLB-154 - Layer 2**

6.4.3 **Layer 3: Signal 1**

Layer 3 (signal) shows how critical controlled impedance and non-critical signals are routed around the WLB-154 device.

6 Reference board breakout and layout recommendations

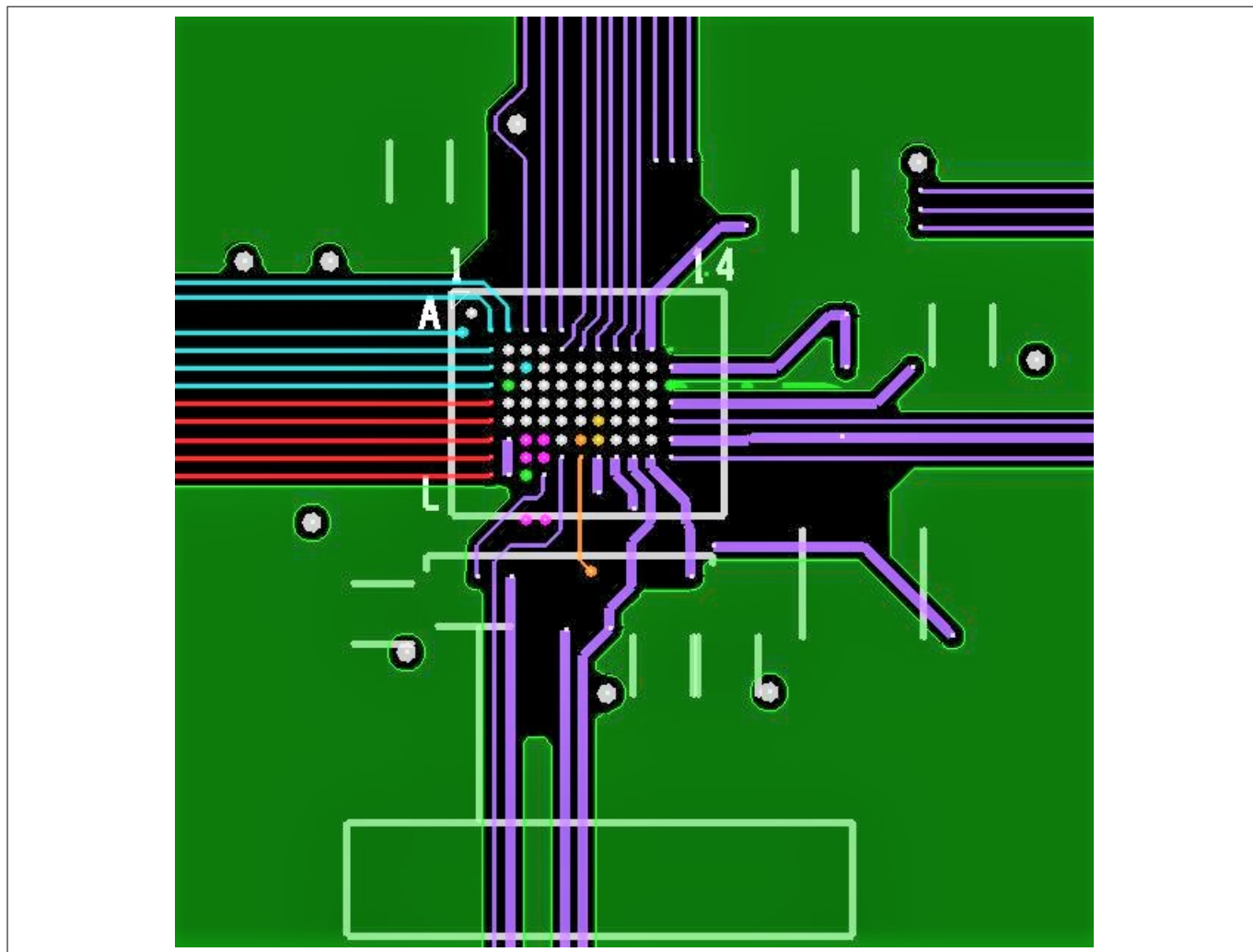


Figure 51 WLB-154 - Layer 3

6.4.4 Layer 4: Signal 2

Layer 4 (signal) shows how all power rails are connected to support high current and low current power signals are routed with adequate trace width around the WLB-154 device.

6 Reference board breakout and layout recommendations

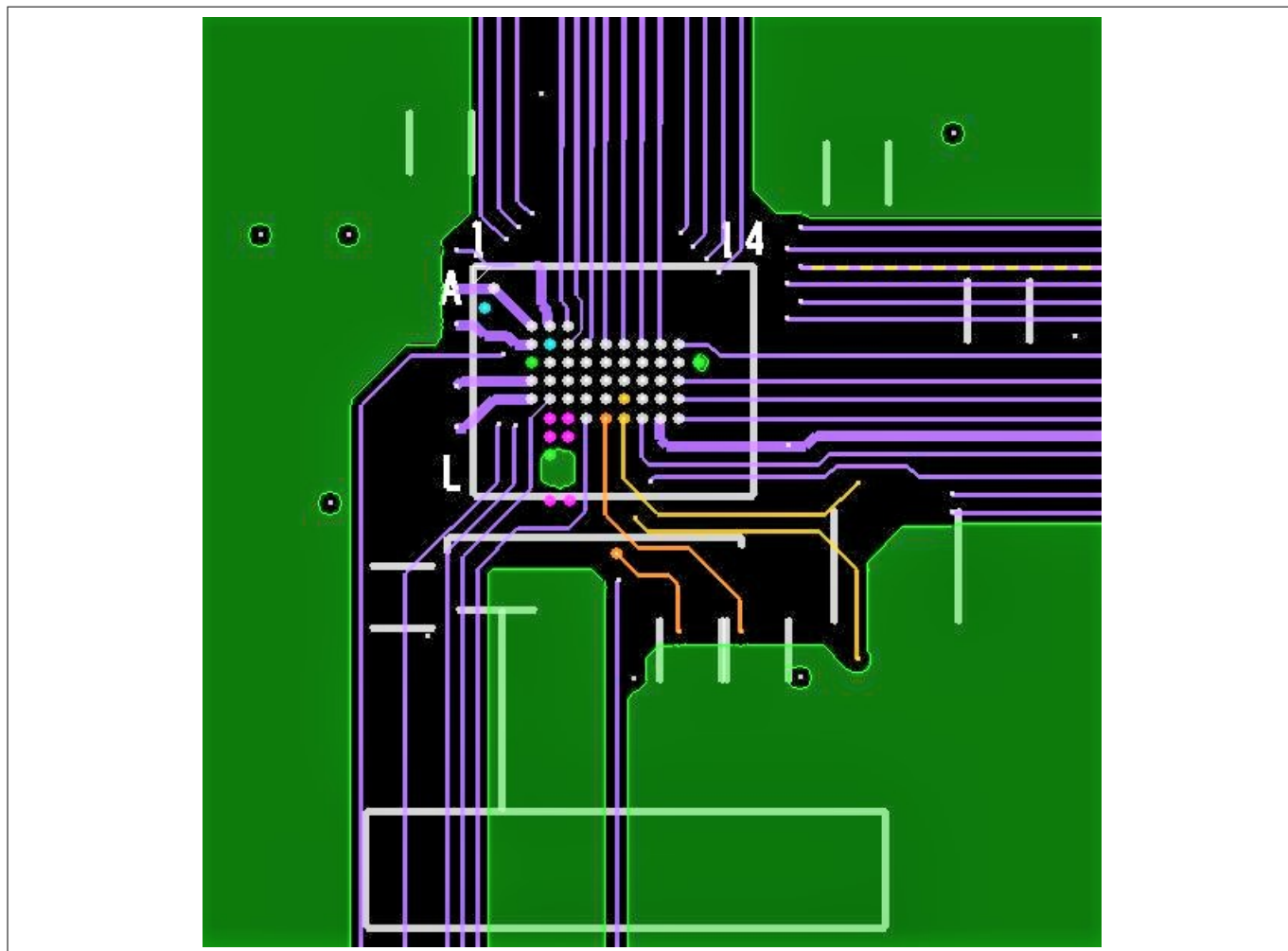


Figure 52 **WLB-154 – Layer 4**

6.4.5 **Layer 5: GND**

Layer 5 (ground plane) shows the solid GND copper plane under the WLB-154 device.

6 Reference board breakout and layout recommendations

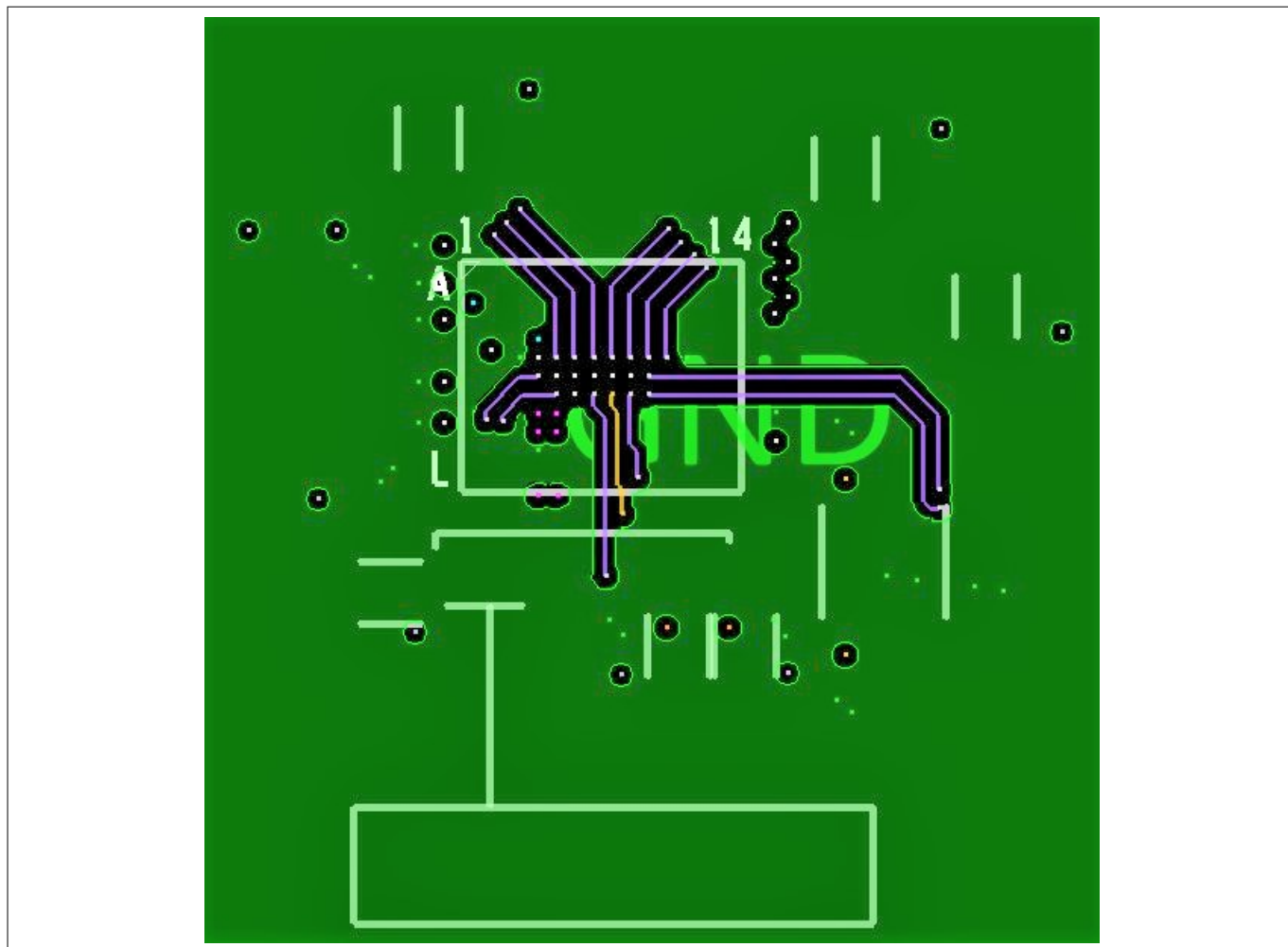


Figure 53 WLB-154 – Layer 5

6.4.6 Bottom layer

Layer 6 (bottom layer) shows how components are placed around the WLB-154 device bottom. The crystal area, critical routing section, and some ground isolation areas are identified.

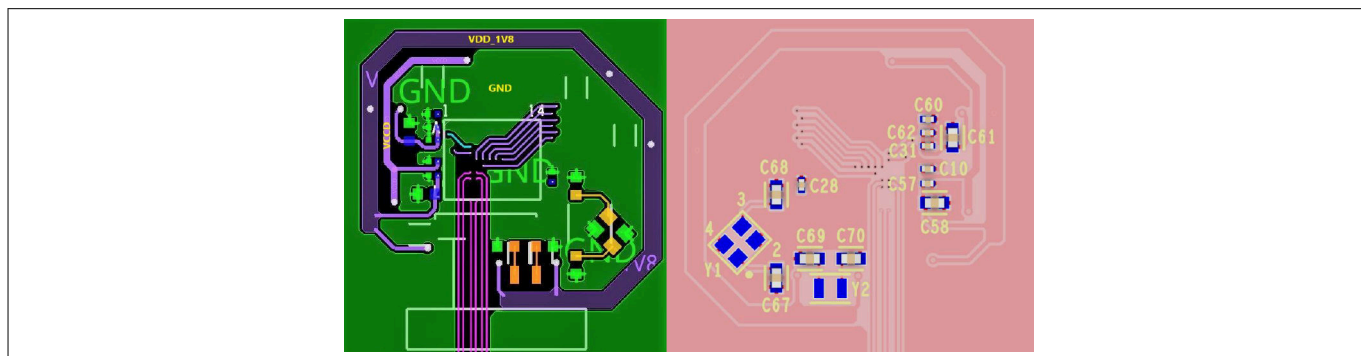


Figure 54 WLB-154 – Layer 6

6 Reference board breakout and layout recommendations

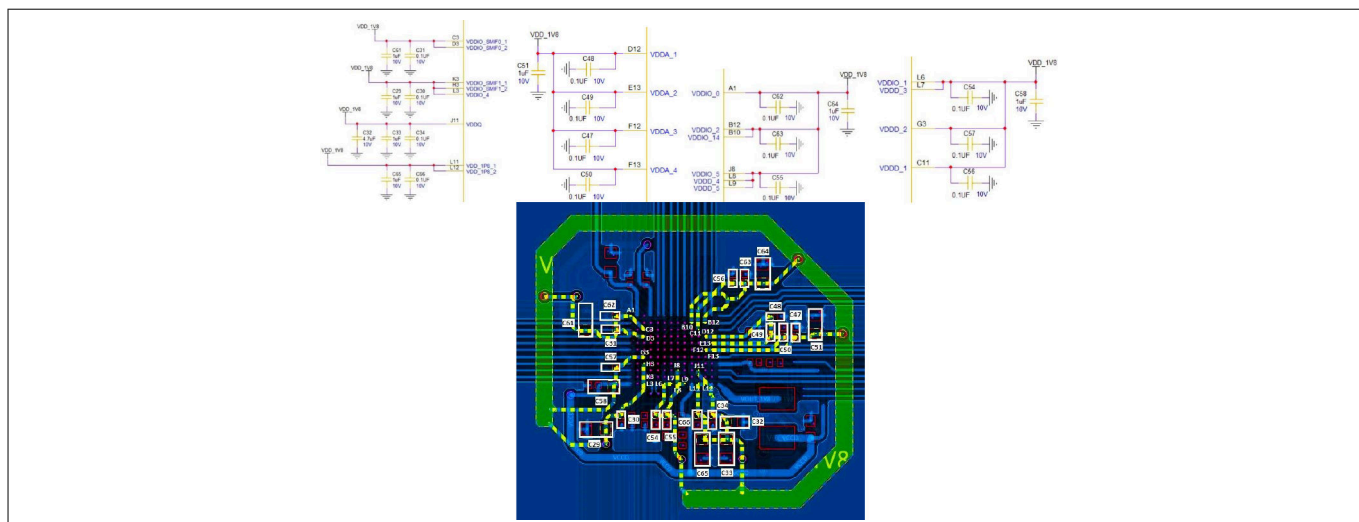


Figure 55 Power rails

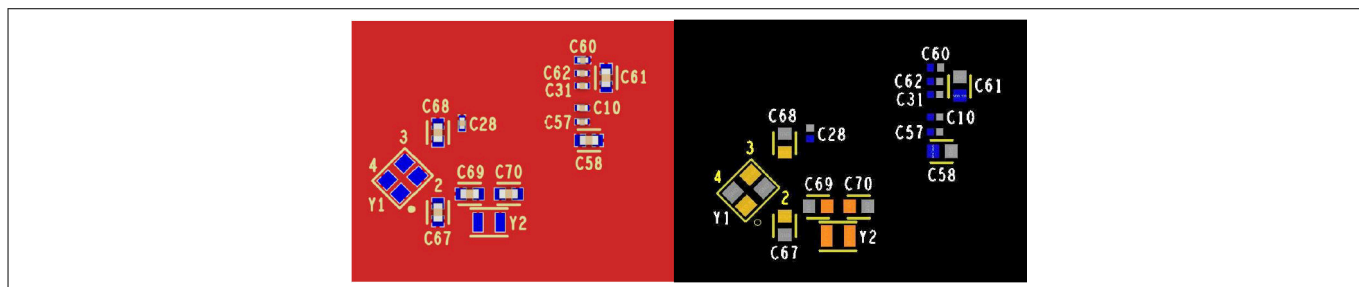


Figure 56 WLB-154 – Bottom layer silkscreen

6.4.7 PCB stack-up and vias recommendation

This PCB stack-up construction is decided based on the component package, considering signal trace density and impedance requirements for high-speed peripherals. It leads to multilayer PCB with dedicated ground and power supply planes. Solid copper planes allow designers to keep the device ground and power connections short.

Further, the ground plane offers low inductance return paths for the high-speed signals.

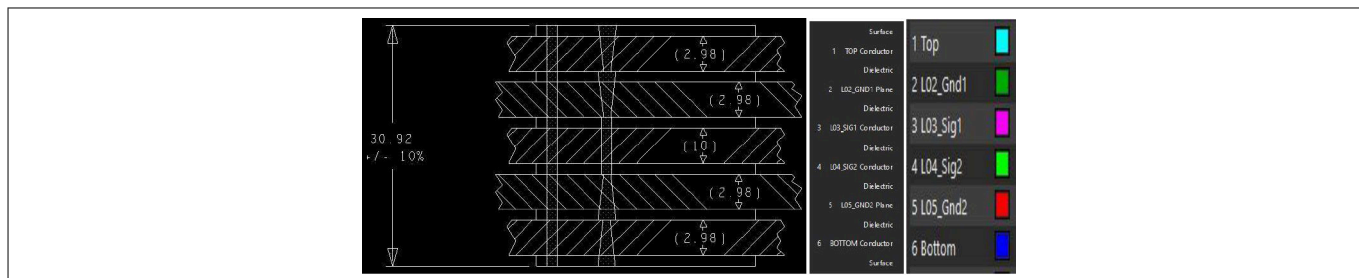


Figure 57 PCB stack-up and vias

To meet signal integrity and performance requirements, a minimum of six-layer stack-up is recommended for implementing end-user systems. The layer stack-ups as shown in the figure are recommended for six-layer boards, although other options are possible. Within a PCB, it may be desirable to run traces using different methods, microstrip vs. strip line, depending on the location of the signal on the PCB. For example, it may be desirable to change layer stacking where a minimum peripheral or limited functionality is used.

7 Layout review checklist

7 Layout review checklist

Table 4 Checklist

No	Schematic checklist	Answer (Yes/No/NA)
1	Are the decoupling capacitors and bulk capacitors placed close to the IC power pins?	
2	Is a 0.1-μF decoupling capacitor placed close to VBAT, VDDIO, VDDA, and VDDD pins?	
3	Are the vias placed close to the controller IC power pins?	
4	Are the power and switching traces routed away from the high-speed (HS) and super-speed (SS) data lines?	
5	Is the crystal circuitry placed close to the IC pin of the controller?	
6	Has a dedicated and continuous VSS plane been used?	
7	Are all power rails using adequate number of vias and have sufficient copper?	
8	Does the stack-up chosen support the controlled impedance requirements?	
9	Do the MIPI DSI and SMIF SS signal lines match in length?	
10	Do the USB SS signal lines match in length?	
11	Are the SMIF0,1 and MIPI SS and HS signal lines provided with a solid ground plane underneath?	
12	Are the MIPI DSI traces kept short?	
13	Do the MIPI traces have minimum bends and no 90-degree bends?	
14	Are the SS and HS signal trace impedance matched 50E and 100E?	

8 Conclusion

8 Conclusion

This application note should be used as a reference when starting a new design with an PSOC™ Edge MCU microcontroller. The recommendations may vary for the various packages.

References

References

Use the references in this section in conjunction with this document.

Note: *Infineon provides customer access to technical documentation and software through [Infineon Support Page](#) and Downloads and Support site (see IoT Resources).*

- [1] Wafer-Level Ball Grid Array Overview and Assembly Guidelines
 - [2] PSOC™ Edge reference design. Contact your local Infineon FAE or sales representative for access to the design package including latest datasheet
 - [3] [EMC and System-ESD Design Guidelines for Board Layout](#)
 - [4] [Design Considerations for Electrical Fast Transient \(EFT\) Immunity](#)
- For more information, several references are available:
- [5] The Circuit Designer's Companion, Second Edition, (EDN Series for Design Engineers), by Tim Williams
 - [6] PCB Design for Real-World EMI Control (The Springer International Series in Engineering and Computer Science), by Bruce R. Archambeault and James Drewniak
 - [7] Printed Circuits Handbook (McGraw Hill Handbooks), by Clyde Coombs
 - [8] EMC and the Printed Circuit Board: Design, Theory, and Layout Made Simple, by Mark I. Montrose
 - [9] Signal Integrity Issues and Printed Circuit Board Design, by Douglas Brooks
 - [10] Rick Hartley's presentation at Altium Live, "The Extreme Importance of PC Board Stack Up" delves into creating the best stack-ups for critical length nets
 - [11] Dr. Bruce Archambeault's book, "PCB Design for Real-World EMI Control," is highly recommended by Rick Hartley for identifying and solving EMI problems

Revision history

Revision history

Document revision	Date	Description of changes
*B	2025-09-19	Release to web

Trademarks

Trademarks

PSOC™, formerly known as PSoC™, is a trademark of Infineon Technologies. Any references to PSoC™ in this document or others shall be deemed to refer to PSOC™.

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2025-09-19

Published by

Infineon Technologies AG
81726 Munich, Germany

© 2025 Infineon Technologies AG
All Rights Reserved.

Do you have a question about any aspect of this document?

Email: erratum@infineon.com

Document reference
IFX-ieb1699534230200

Important notice

The information contained in this application note is given as a hint for the implementation of the product only and shall in no event be regarded as a description or warranty of a certain functionality, condition or quality of the product. Before implementation of the product, the recipient of this application note must verify any function and other technical information given herein in the real application. Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind (including without limitation warranties of non-infringement of intellectual property rights of any third party) with respect to any and all information given in this application note.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Warnings

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.